Description

Mxxxx204 is a magneto-resistive random-access memory (MRAM). It is offered in density ranging from 4Mbit to 16Mbit. MRAM technology is analogous to Flash technology with SRAM compatible read/write timings (Persistent SRAM, P-SRAM). Data is always non-volatile.

MRAM is a true random-access memory; allowing both reads and writes to occur randomly in memory. MRAM is ideal for applications that must store and retrieve data without incurring large latency penalties. It offers low latency, low power, virtually infinite endurance and retention, and scalable non-volatile memory technology.

Mxxxx204 is available in small footprint 8-pad DFN (WSON) and 8-pin SOIC packages. These packages are compatible with similar low-power volatile and non-volatile products.

Mxxxx204 is offered with industrial (-40°C to 85°C) and industrial plus (-40°C to 105°C) operating temperature ranges.

Typical Applications

- Ideal for applications that must store and retrieve data without incurring large latency penalties.
- Factory Automation
- Multifunction Printers
- Industrial Control And Monitoring
- Medical Diagnostics
- Data Switches And Routers

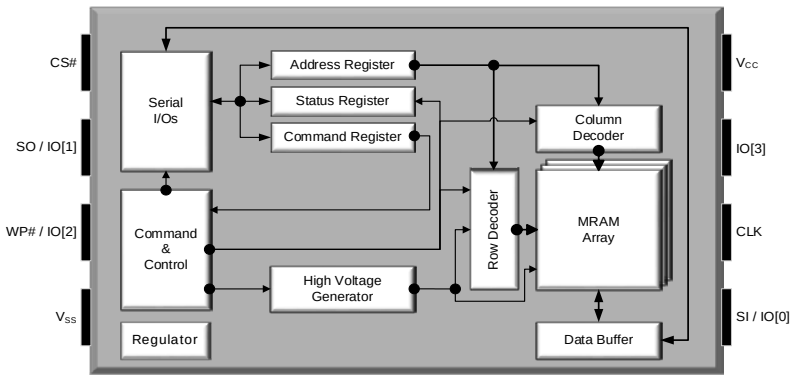
Features

- Interface
  - Serial Peripheral Interface QSPI (4-4-4)
  - Single Data Rate Mode: 108MHz
  - Double Data Rate Mode: 54MHz
- Technology
  - 40nm pMTJ STT-MRAM

  Virtually unlimited Endurance and Data Retention (see Endurance and Data Retention specification on page 38)
- Density
  - 4Mb, 8Mb, 16Mb
- Operating Voltage Range
  - VCC: 1.71V – 2.00V
  - VCC: 2.70V – 3.60V
- Operating Temperature Range
  - Industrial: -40°C to 85°C
  - Industrial Plus: -40°C to 105°C
- Packages
  - 8-pad DFN (WSON) (5.0mm x 6.0mm)
  - 8-pin SOIC (5.2mm x 5.2mm)
- Data Protection
  - Hardware Based: Write Protect Pin (WP#)

  Software Based: Address Range Selectable through Configuration bits (Top/Bottom, Block Protect[2:0])
- Identification
  - 64-bit Unique ID
  - 64-bit User Programmable Serial Number
- Augmented Storage Array
  - 256-byte User Programmable with Write Protection
- Supports JEDEC Reset
- RoHS Compliant

Block Diagram



Contents

1. Performance

Device Operation	Typical Values	Units
Frequency of Operation	108 (maximum)	MHz
Standby Current	160 (typical)	µA
Deep Power Down Current	5 (typical)	µA
Hibernate Current	0.1 (typical)	µA
Active Read Current – (4-4-4) SDR @ 108MHz	19 (typical)	mA
Active Write Current – (4-4-4) SDR @ 108MHz	38 (typical)	mA

2. General Description

Mxxxx204 is a magneto-resistive random-access memory (MRAM). It is offered in density ranging from 4Mbit to 16Mbit. MRAM technology is analogous to Flash technology with SRAM compatible read/write timings (Persistent SRAM, P-SRAM). Data is always non-volatile.

Figure 1: Technology Comparison

	SRAM	Flash	EEPROM	MRAM
Non-Volatility	–	√	√	√
Write Performance	√	–	–	√
Read Performance	√	–	–	√
Endurance	√	–	–	√
Power	–	–	–	√

MRAM is a true random-access memory; allowing both reads and writes to occur randomly in memory. MRAM is ideal for applications that must store and retrieve data without incurring large latency penalties. It offers low latency, low power, virtually infinite endurance and retention, and scalable non-volatile memory technology.

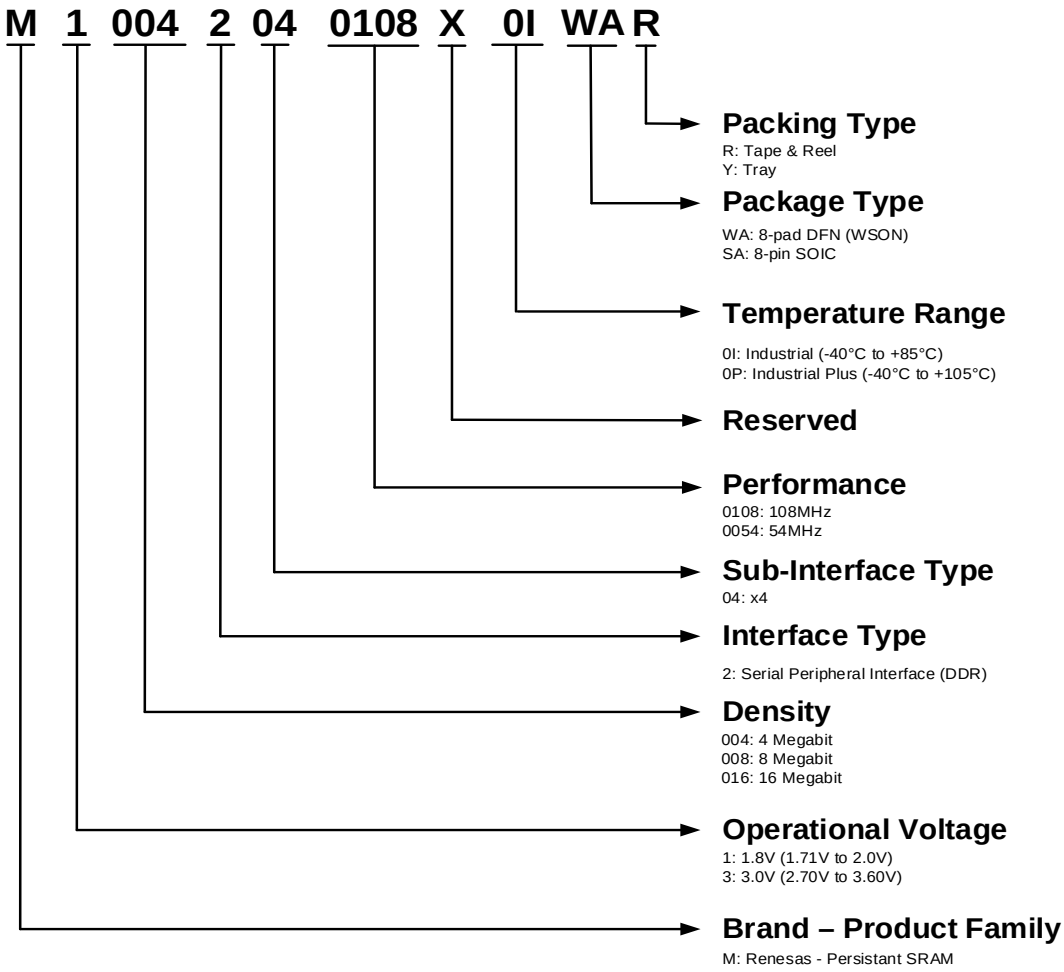
Mxxxx204 has a Serial Peripheral Interface (SPI). SPI is a synchronous interface which uses separate lines for data and clock to help keep the host and slave in perfect synchronization. The clock tells the receiver exactly when to sample the bits on the data line. This can be either the rising (low to high) or falling (high to low) or both edges of the clock signal; please consult the instruction sequences in this datasheet for more details. When the receiver detects that correct edge, it can latch in the data.

Mxxxx204 is available in small footprint 8-pad DFN (WSON) and 8-pin SOIC packages. These packages are compatible with similar low-power volatile and non-volatile products.

Mxxxx204 is offered with industrial (-40°C to 85°C) and industrial plus (-40°C to 105°C) operating temperature ranges.

3. Ordering Options

The ordering part numbers are formed by a valid combination of the following options:



3.1 Valid Combinations — Standard

Valid Combinations list includes device configurations currently available. Contact your local sales office to confirm availability of specific valid combinations and to check on newly released combinations.

Table 1: Valid Combinations List

Valid Combinations – 108MHz				
Base Part Number	**Temperature Range**	**Package Type**	**Packing Type**	**Part Number**
M10042040108X	0I, 0P	WA, SA	R, Y	M10042040108X0IWAR
				M10042040108X0IWAY
				M10042040108X0ISAR
				M10042040108X0ISAY
				M10042040108X0PWAR
				M10042040108X0PWAY
				M10042040108X0PSAR
				M10042040108X0PSAY
M30042040108X	0I, 0P	WA, SA	R, Y	M30042040108X0IWAR
				M30042040108X0IWAY
				M30042040108X0ISAR
				M30042040108X0ISAY
				M30042040108X0PWAR
				M30042040108X0PWAY
				M30042040108X0PSAR
				M30042040108X0PSAY
M10082040108X	0I, 0P	WA, SA	R, Y	M10082040108X0IWAR
				M10082040108X0IWAY
				M10082040108X0ISAR
				M10082040108X0ISAY
				M10082040108X0PWAR
				M10082040108X0PWAY
				M10082040108X0PSAR
				M10082040108X0PSAY
M30082040108X	0I, 0P	WA, SA	R, Y	M30082040108X0IWAR
				M30082040108X0IWAY
				M30082040108X0ISAR
				M30082040108X0ISAY
				M30082040108X0PWAR
				M30082040108X0PWAY
				M30082040108X0PSAR
				M30082040108X0PSAY
M10162040108X	0I, 0P	WA, SA	R, Y	M10162040108X0IWAR
				M10162040108X0IWAY
				M10162040108X0ISAR
				M10162040108X0ISAY
				M10162040108X0PWAR
				M10162040108X0PWAY
				M10162040108X0PSAR
				M10162040108X0PSAY
M30162040108X	0I, 0P	WA, SA	R, Y	M30162040108X0IWAR
				M30162040108X0IWAY
				M30162040108X0ISAR
				M30162040108X0ISAY
				M30162040108X0PWAR
				M30162040108X0PWAY
				M30162040108X0PSAR
				M30162040108X0PSAY

Valid Combinations – 54MHz				
Base Part Number	**Temperature Range**	**Package Type**	**Packing Type**	**Part Number**
M10042040054X	0I, 0P	WA, SA	R, Y	M10042040054X0IWAR
				M10042040054X0IWAY
				M10042040054X0ISAR
				M10042040054X0ISAY
				M10042040054X0PWAR
				M10042040054X0PWAY
				M10042040054X0PSAR
				M10042040054X0PSAY
M30042040054X	0I, 0P	WA, SA	R, Y	M30042040054X0IWAR
				M30042040054X0IWAY

Valid Combinations – 54MHz				
Base Part Number	**Temperature Range**	**Package Type**	**Packing Type**	**Part Number**
				M30042040054X0ISAR
				M30042040054X0ISAY
				M30042040054X0PWAR
				M30042040054X0PWAY
				M30042040054X0PSAR
				M30042040054X0PSAY
M10082040054X	0I, 0P	WA, SA	R, Y	M10082040054X0IWAR
				M10082040054X0IWAY
				M10082040054X0ISAR
				M10082040054X0ISAY
				M10082040054X0PWAR
				M10082040054X0PWAY
				M10082040054X0PSAR
				M10082040054X0PSAY
M30082040054X	0I, 0P	WA, SA	R, Y	M30082040054X0IWAR
				M30082040054X0IWAY
				M30082040054X0ISAR
				M30082040054X0ISAY
				M30082040054X0PWAR
				M30082040054X0PWAY
				M30082040054X0PSAR
				M30082040054X0PSAY
M10162040054X	0I, 0P	WA, SA	R, Y	M10162040054X0IWAR
				M10162040054X0IWAY
				M10162040054X0ISAR
				M10162040054X0ISAY
				M10162040054X0PWAR
				M10162040054X0PWAY
				M10162040054X0PSAR
				M10162040054X0PSAY
M30162040054X	0I, 0P	WA, SA	R, Y	M30162040054X0IWAR
				M30162040054X0IWAY
				M30162040054X0ISAR
				M30162040054X0ISAY
				M30162040054X0PWAR
				M30162040054X0PWAY
				M30162040054X0PSAR
				M30162040054X0PSAY

4. Signal Description and Assignment

Figure 2: Device Pinout

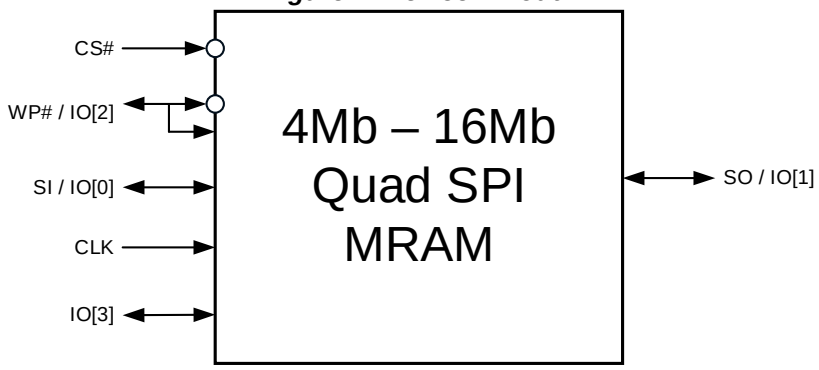


Table 2: Signal Description

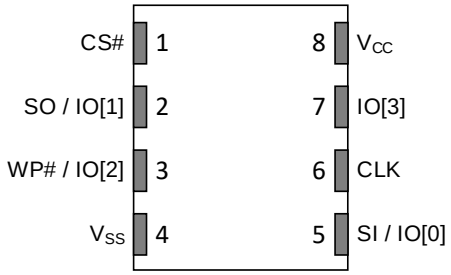
Signal	Type	Description
CS#	Input	**Chip Select:** When CS# is driven High, the device will enter standby mode. All other input pins are ignored and the output pin is tri-stated. Driving CS# Low enables the device, placing it in the active mode. After power-up, a falling edge on CS# is required prior to the start of any instructions.
WP# / IO[2]	Input / Bidirectional	**Write Protect (SPI):** Write protects the status register in conjunction with the enable/disable bit of the status register. This is important since other write protection features are controlled through the Status Register. When the enable/disable bit of the status register is set to 1 and the WP# signal is driven Low, the status register becomes read-only and the WRITE STATUS REGISTER operation will not execute. This signal does not have internal pull-ups, it cannot be left floating and must be driven. WP# is valid only in Single SPI mode. **Bidirectional Data 2 (DPI/QPI):** The bidirectional I/O transfers data into and out of the device in Dual and Quad SPI modes.
CLK	Input	**Clock:** Provides the timing for the serial interface. Depending on the mode selected, either single (rising or falling) edge or both edges of the clock are utilized for information transfer. In Single Data Rate mode (SDR) command, address and data inputs are latched on the rising edge of the clock. Data is output on the falling edge of the clock. In Double Data Rate mode (DDR) command is latched on the rising edge of the clock. Address and Data inputs are latched on both edges of the clock. Similarly, Data is output on both edges of the clock. The following two SPI clock modes are supported. • *SPI Mode 0 (CPOL = 0, CPHA = 0) – SDR and DDR* • *SPI Mode 3 (CPOL = 1, CPHA = 1) – SDR only*
IO[3]	Bidirectional	**Bidirectional Data 3 (DPI/QPI):** The bidirectional I/O transfers data into and out of the device in Dual and Quad SPI modes.
SI / IO[0]	Input / Bidirectional	**Serial Data Input (SPI):** The unidirectional I/O transfers data into the device on the rising edge of the clock in Single SPI mode. **Bidirectional Data 0 (DPI/QPI):** The bidirectional I/O transfers data into and out of the device in Dual and Quad SPI modes.

Signal	Type	Description
SO / IO[1]	Output / Bidirectional	**Serial Data Output (SPI):** The unidirectional I/O transfers data out of the device on the falling edge of the clock in Single SPI mode. **Bidirectional Data 1 (DPI/QPI):** The bidirectional I/O that transfers data into and out of the device in Dual and Quad SPI modes.
V_{CC}	Supply	**V_{CC}:** Core and I/O power supply.
V_{SS}	Supply	**V_{SS}:** Core and I/O ground supply.

5. Package Options

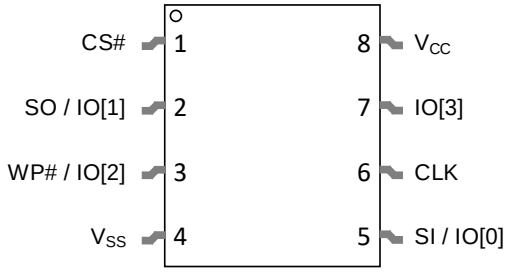
5.1 8-Pad DFN (WSON) (Top View)

Figure 3: 8-Pad DFN (WSON)



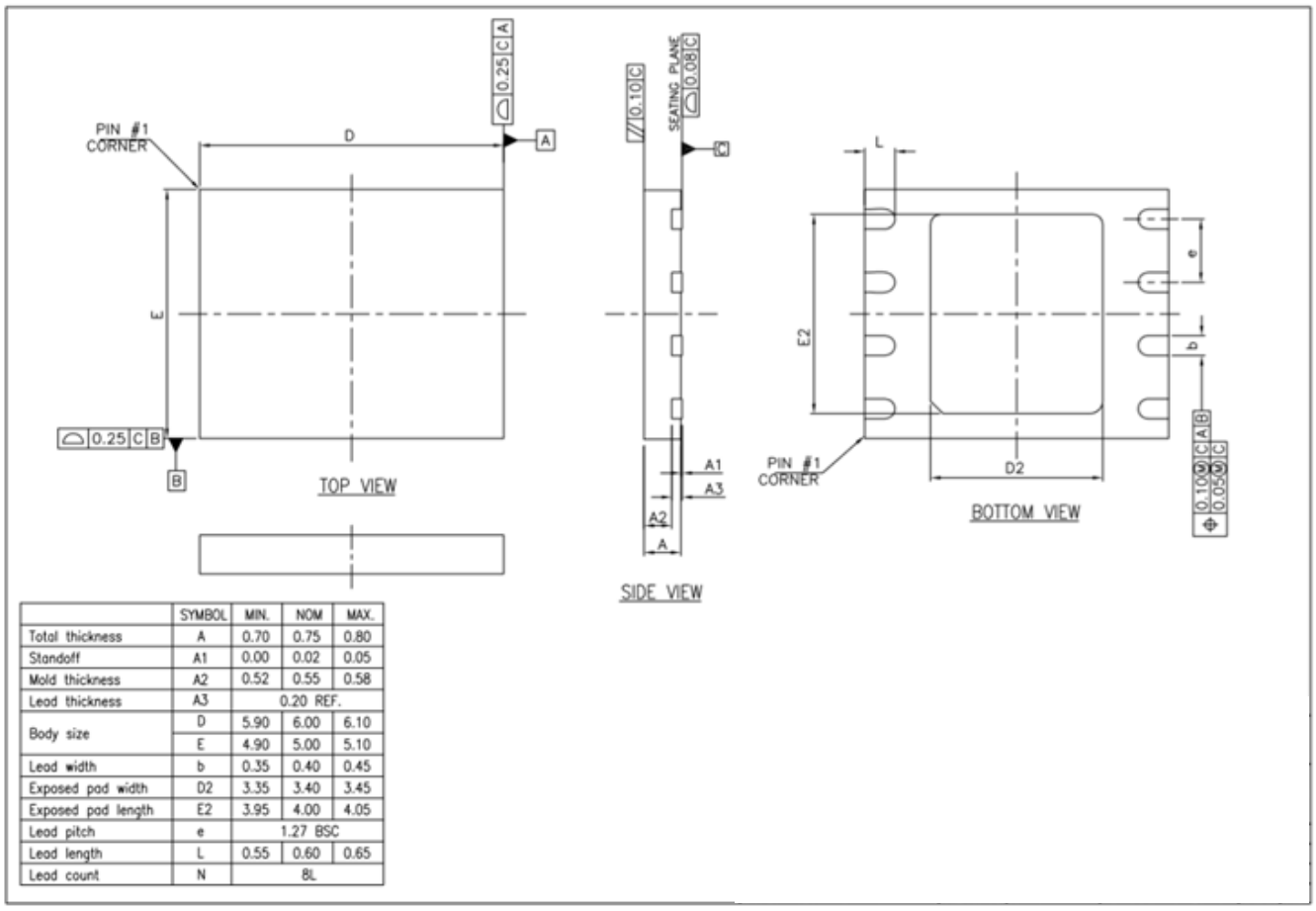
5.2 8-Pin SOIC (Top View)

Figure 4: 8-Pin SOIC



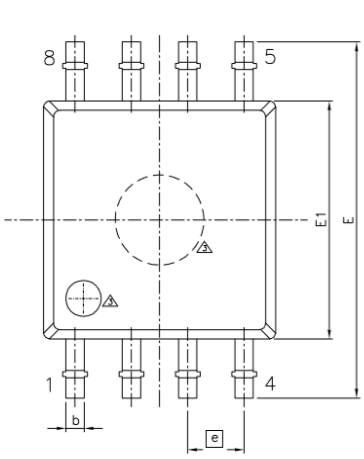
6. Package Drawings

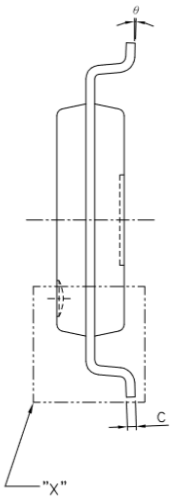
6.1 8-Pad DFN (WSON)



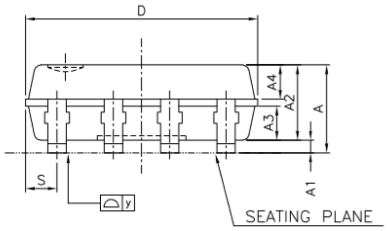
	SYMBOL	MIN.	NOM	MAX.
Total thickness	A	0.70	0.75	0.80
Standoff	A1	0.00	0.02	0.05
Mold thickness	A2	0.52	0.55	0.58
Lead thickness	A3		0.20 REF.	
Body size	D	5.90	6.00	6.10
	E	4.90	5.00	5.10
Lead width	b	0.35	0.40	0.45
Exposed pad width	D2	3.35	3.40	3.45
Exposed pad length	E2	3.95	4.00	4.05
Lead pitch	e		1.27 BSC	
Lead length	L	0.55	0.60	0.65
Lead count	N		8L	

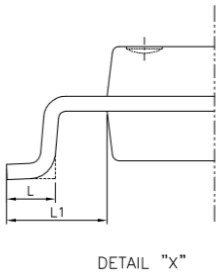
6.2 8-Pin SOIC





SYMBOL	DIMENSION (MM)			DIMENSION (MIL)		
	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.
A	———	———	2.16	———	———	85.04
A1	0.05	0.15	0.25	1.97	5.91	9.84
A2	1.70	1.80	1.91	66.93	70.87	75.20
A3	0.773	0.798	0.823	30.43	31.42	32.40
A4	0.773	0.798	0.823	30.43	31.42	32.40
b	0.36	0.41	0.51	14.17	16.14	20.08
C	0.19	0.20	0.25	7.48	7.87	9.84
D	5.13	5.23	5.33	201.97	205.91	209.84
E	7.70	7.90	8.10	303.15	311.02	318.90
E1	5.18	5.28	5.38	203.94	207.87	211.81
e	1.27 BSC			50 BSC		
L	0.50	0.65	0.80	19.69	25.59	31.50
L1	1.27	1.37	1.47	50.00	53.94	57.87
S	0.62	0.74	0.88	24.41	29.13	34.65
φ	0°	5°	8°	0°	5°	8°
y	———	———	0.075	———	———	2.95





NOTE:

1. DIMENSION "D" DOES NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS. MOLD FLASH, PROTRUSIONS AND GATE BURRS SHALL NOT EXCEED 0,15mm (6mil) PER SIDE.
2. DIMENSION "E" DOES NOT INCLUDE INTERLEAD FLASH OR PROTRUSIONS. INTER-LEAD FLASH AND PROTRUS SHALL NOT EXCEED 0,25mm (10 mil) PER SIDE.
3. CONTROLLING DIMENSION: MILLIMETER

7. Architecture

Mxxxx204 is a high performance serial STT-MRAM device. It features a SPI-compatible bus interface running at 108MHz, eXecute-In-Place (XIP) functionality, and hardware/software based data protection mechanisms.

When CS# is Low, the device is selected and in active power mode. When CS# is High, the device is deselected but can remain in active power mode until ongoing internal operations are completed. Then the device goes into standby power mode and device current consumption drops to I_{SB}.

Mxxxx204 contains an 8-bit instruction register. All functionality is controlled through the values loaded into this instruction register. In Single SPI mode, the device is accessed via the SI / IO[0] pin. In Dual and Quad SPI modes, IO[0:1] and IO[0:3] are used to access the device respectively. Furthermore, Single Data Rate (SDR) and Double Data Rate (DDR) instructions utilize CLK edges differently to transfer information; SDR uses a single CLK edge whereas DDR uses both edges of CLK. ***Table 3*** summarizes all the different interface modes supported and their respective I/O usage. ***Table 4*** shows the clock edge used for each instruction component.

Nomenclature adoption: A typical SPI instruction consists of command, address and data components. The bus width to transmit these three components varies based on the SPI interface mode selected. To accurately represent the number of I/Os used to transmit these three components, a nomenclature (command-address-data) is adopted and used throughout this document. Integers placed in the (command-address-data) fields represent the number of I/Os used to transmit the particular component. As an example, 1-1-1 means command, address and data are transmitted on a single I/O (SI / IO[0] or SO / IO[1]). On the other hand, 1-4-4 represents command being sent on a single I/O (SI / IO[0]) and address/data being sent on four I/Os (IO[3:0]).

Table 3: Interface Modes of Operations

Instruction Component	Single SPI (1-1-1)	Dual Input Output SPI (1-1-2)	Dual I/O SPI (1-2-2)	DPI (2-2-2)	Quad Input Output SPI (1-1-4)	Quad I/O SPI (1-4-4)	QPI (4-4-4)
Command	SI / IO[0]	SI / IO[0]	SI / IO[0]	IO[1:0]	SI / IO[0]	SI / IO[0]	IO[3:0]
Address	SI / IO[0]	SI / IO[0]	IO[1:0]	IO[1:0]	SI / IO[0]	IO[3:0]	IO[3:0]
Data Input	SI / IO[0]	IO[1:0]	IO[1:0]	IO[1:0]	IO[3:0]	IO[3:0]	IO[3:0]
Data Output	SO / IO[1]	IO[1:0]	IO[1:0]	IO[1:0]	IO[3:0]	IO[3:0]	IO[3:0]

Table 4: Clock Edge Used for instructions in SDR and DDR modes

Instruction Type	Command	Address	Data Input	Data Output
(1-1-1) SDR	R	R	R	F 1
(1-1-1) DDR	R	R F	R F	F R 1
(1-1-2) SDR	R	R	R	F 1
(1-2-2) SDR	R	R	R	F 1
(2-2-2) SDR	R	R	R	F 1
(2-2-2) DDR	R	R F	R F	F R 1
(1-1-4) SDR	R	R	R	F 1
(1-4-4) SDR	R	R	R	F 1
(1-4-4) DDR	R	R F	R F	F R 1
(4-4-4) SDR	R	R	R	F 1
(4-4-4) DDR	R	R F	R F	F R 1

Notes:
R: Rising Clock Edge
F: Falling Clock Edge
1: Data output from Mxxxx204 always begins on the falling edge of the clock – SDR & DDR

Mxxxx204 supports eXecute-In-Place (XIP) which allows completing a series of read and write instructions without having to individually load the read or write command for each instruction. Thus, XIP mode saves command overhead and reduces random read & write access time. A special XIP byte must be entered after the address bits to enable/disable (Axh/Fxh) XIP.

Mxxxx204 offers both hardware and software based data protection schemes. Hardware protection is through WP# pin. Software protection is controlled by configuration bits in the Status register. Both schemes inhibit writing to the registers and memory array.

Mxxxx204 has a 256-byte Augmented Storage Array which is independent from the main memory array. It is user programmable and can be write protected against inadvertent writes.

Two lower power states are available in Mxxxx204, namely Deep Power Down and Hibernate. Data is not lost while the device is in either of these two low power states. Moreover, the device maintains all its configurations.

Figure 5: Functional Block Diagram

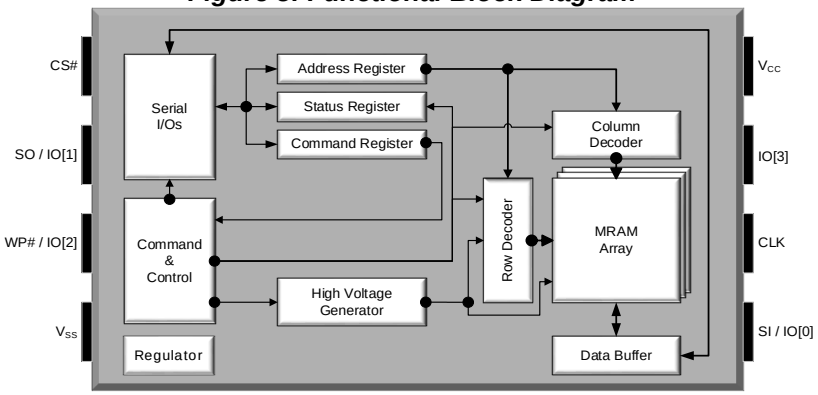


Table 5: Modes of Operation

Mode	Current	CS#	CLK	SI / IO[3:0]	SO / IO[3:0]
Standby	I_{SB}	H	Gated	Gated / Hi-Z	Hi-Z / Hi-Z
Active - Read	I_{READ}	L	Toggle	Command, Address	Data Output
Active - Write	I_{WRITE}	L	Toggle	Command, Address, Data Input	Hi-Z
Deep Power Down	I_{DPD}	H	Gated	Gated / Hi-Z	Hi-Z / Hi-Z
Hibernate	I_{HBN}	H	Gated	Gated / Hi-Z	Hi-Z / Hi-Z

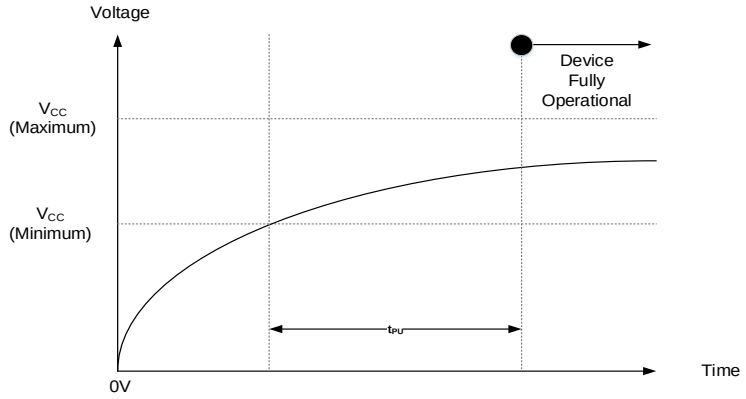
Notes:
H: High (Logic ‘1’)
L: Low (Logic ‘0’)
Hi-Z: High Impedance

8. Device Initialization

When powering up, the following procedure is required to initialize the device correctly:

- *Ramp up V_{CC} (R_{VR})*
- *CS# must follow V_{CC} during power-up (a 10KΩ pull-up Resistor to V_{CC} is recommended)*
- *It is recommended that no instructions are sent to the device when V_{CC} is below V_{CC} (minimum)*
- *During initial Power-up, recovering from power loss or brownout, a delay of t_{PU} is required before normal operation commences*
- *Upon Power-up, the device is in Standby mode*

Figure 6: Power-Up Behavior



When powering down, the following procedure is required to turn off the device correctly:

- *Ramp down V_{CC} (R_{VF})*
- *CS# must follow V_{CC} during power-down (a 10KΩ pull-up Resistor to V_{CC} is recommended)*
- *It is recommended that no instructions are sent to the device when V_{CC} is below V_{CC} (minimum)*
- *The Power-up timing needs to be observed after V_{CC} goes above V_{CC} (minimum)*

Figure 7: Power-Down Behavior

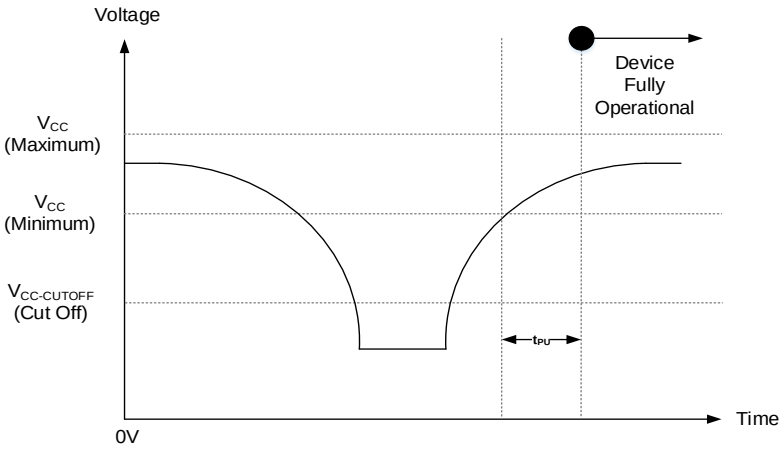


Table 6: Power Up/Down Timing – 3.0V

Parameter	Symbol	Test Conditions	3.0V			
			Minimum	Typical	Maximum	Units
V_{CC} Range	V_{CC}	All operating voltages and temperatures	2.7	-	3.6	V
V_{CC} Ramp Up Time	R_{VR}		30	-	-	µs/V
V_{CC} Ramp Down Time	R_{VF}		20	-	-	µs/V
V_{CC} Power Up to First Instruction	t_{PU}		250	-	-	µs
V_{CC} Cutoff – Must Initialize Device	$V_{CC\text{-}CUTOFF}$		1.6	-	-	V
Time to Enter Deep Power Down	t_{EDPD}		-	-	3	µs
Time to Exit Deep Power Down	t_{EXDPD}		-	-	400	µs
Time to Enter Hibernate	t_{ENTHIB}		-	-	3	µs
Time to Exit Hibernate	t_{EXHIB}		-	-	450	µs
CS# Pulse Width	t_{CSDPD}		50	-	-	ns

Table 7: Power Up/Down Timing – 1.8V

Parameter	Symbol	Test Conditions	1.8V			
			Minimum	Typical	Maximum	Units
V_{CC} Range	V_{CC}	All operating voltages and temperatures	1.71	-	2.0	V
V_{CC} Ramp Up Time	R_{VR}		30	-	-	µs/V
V_{CC} Ramp Down Time	R_{VF}		20	-	-	µs/V
V_{CC} Power Up to First Instruction	t_{PU}		250	-	-	µs
V_{CC} Cutoff – Must Initialize Device	$V_{CC\text{-}CUTOFF}$		1.6	-	-	V
Time to Enter Deep Power Down	t_{EDPD}		-	-	3	µs
Time to Exit Deep Power Down	t_{EXDPD}		-	-	400	µs
Time to Enter Hibernate	t_{ENTHIB}		-	-	3	µs
Time to Exit Hibernate	t_{EXHIB}		-	-	450	µs
CS# Pulse Width	t_{CSDPD}		50	-	-	ns

9. Memory Map

Table 8: Memory Map

Density	Address Range	24-bit Address [23:0]	
4Mb	000000h – 07FFFFh	[23:19] – Logic '0'	[18:0] - Addressable
8Mb	000000h – 0FFFFFh	[23:20] – Logic '0'	[19:0] - Addressable
16Mb	000000h – 1FFFFFh	[23:21] – Logic '0'	[20:0] - Addressable

10. Augmented Storage Array Map

Table 9: Augmented Storage Array Map

Density	Address Range	24-bit Address [23:0]	
4Mb	000000h – 0000FFh [1]	[23:8] – Logic '0'	[7:0] - Addressable
8Mb	000000h – 0000FFh [1]	[23:8] – Logic '0'	[7:0] - Addressable
16Mb	000000h – 0000FFh [1]	[23:8] – Logic '0'	[7:0] - Addressable

Notes:
1: The 256-byte augmented storage array is divided into 8 individually readable and writeable sections (32 bytes per section). After an individual section is programmed, it can be write protected to prevent further programming.

Table 10: Individual Section Address Range

Section	Address Range	24-bit Address [23:0]	
0	000000h – 00001Fh	[23:8] – Logic '0'	[7:0] - Addressable
1	000020h – 00003Fh	[23:8] – Logic '0'	[7:0] - Addressable
2	000040h – 00005Fh	[23:8] – Logic '0'	[7:0] - Addressable
3	000060h – 00007Fh	[23:8] – Logic '0'	[7:0] - Addressable
4	000080h – 00009Fh	[23:8] – Logic '0'	[7:0] - Addressable
5	0000A0h – 0000BFh	[23:8] – Logic '0'	[7:0] - Addressable
6	0000C0h – 0000DFh	[23:8] – Logic '0'	[7:0] - Addressable
7	0000E0h – 0000FFh	[23:8] – Logic '0'	[7:0] - Addressable

11. Register Addresses

Table 11: Register Addresses

Register Name	Address
Status Register	0x000000h
Configuration Register 1	0x000002h
Configuration Register 2	0x000003h
Configuration Register 3	0x000004h
Configuration Register 4	0x000005h
Device Identification Register	0x000030h
Unique Identification Register	0x000040h

Note:
1: Register address space is different from the memory array and augmented storage array.

MRAM INITIALIZATION REQUIREMENT

After reflow temp cycle, MRAM Registers must be reconfigured to default settings. Please see the apps note; "Programming Non-Volatile Registers to Factory Default State Post-Reflow Application Note" for details.

12. Register Map

12.1 Status Register / Device Protection Register (Read/Write)

Status register is a legacy SPI register and contains options for enabling/disabling data protection.

Table 12: Status Register – Read and Write

Bits	Name	Description	Read / Write	Default State	Selection Options
SR[7]	WP#EN	Hardware Based WP# Protection Enable/Disable	R/W	0	1: Protection Enabled – write protects when WP# is Low 0: Protection Disabled – Doesn't write protect when WP# is Low
SR[6]	SNPEN	Serial Number Protection Enable/Disable	R/W	0	1: S/N Write protected - protection enabled 0: S/N Writable - protection disabled
SR[5]	TBSEL	Software Top/Bottom Memory Array Protection Selection	R/W	0	1: Bottom Protection Enabled (Lower Address Range) 0: Top Protection Enabled (Higher Address Range)
SR[4]	BPSEL[2]	Block Protect Selection Bit 2	R/W	0	Block Protection Bits (Table 13, Table 14)
SR[3]	BPSEL[1]	Block Protect Selection Bit 1	R/W	0	
SR[2]	BPSEL[0]	Block Protect Selection Bit 0	R/W	0	
SR[1]	WREN	Write Operation Protection Enable/Disable	R	0	1: Write Operation Protection Disabled 0: Write Operation Protection Enabled
SR[0]	RSVD	Reserved	R	0	Reserved for future use

Table 13: Top Block Protection Address Range Selection (TBPSEL=0)

BPSEL [2]	BPSEL [1]	BPSEL [0]	Protected Portion	4Mb	8Mb	16Mb
0	**0**	**0**	None	None	None	None
0	**0**	**1**	Upper 1/64	07E000h – 07FFFFh	0FC000h – 0FFFFFh	1F8000h – 1FFFFFh
0	**1**	**0**	Upper 1/32	07C000h – 07FFFFh	0F8000h – 0FFFFFh	1F0000h – 1FFFFFh
0	**1**	**1**	Upper 1/16	078000h – 07FFFFh	0F0000h – 0FFFFFh	1E0000h – 1FFFFFh
1	**0**	**0**	Upper 1/8	070000h – 07FFFFh	0E0000h – 0FFFFFh	1C0000h – 1FFFFFh
1	**0**	**1**	Upper 1/4	060000h – 07FFFFh	0C0000h – 0FFFFFh	180000h – 1FFFFFh
1	**1**	**0**	Upper 1/2	040000h – 07FFFFh	080000h – 0FFFFFh	1F0000h – 1FFFFFh
1	**1**	**1**	All	000000h – 07FFFFh	000000h – 0FFFFFh	000000h – 1FFFFFh

Table 14: Bottom Block Protection Address Range Selection (TBPSEL=1)

BPSEL [2]	BPSEL [1]	BPSEL [0]	Protected Portion	4Mb	8Mb	16Mb
0	**0**	**0**	None	None	None	None
0	**0**	**1**	Lower 1/64	000000h – 001FFFh	000000h – 003FFFh	000000h – 007FFFh
0	**1**	**0**	Lower 1/32	000000h – 003FFFh	000000h – 007FFFh	000000h – 00FFFFh

BPSEL [2]	BPSEL [1]	BPSEL [0]	Protected Portion	4Mb	8Mb	16Mb
0	**1**	**1**	Lower 1/16	000000h – 007FFFh	000000h – 00FFFFh	000000h – 01FFFFh
1	**0**	**0**	Lower 1/8	000000h – 00FFFFh	000000h – 01FFFFh	000000h – 03FFFFh
1	**0**	**1**	Lower 1/4	000000h – 01FFFFh	000000h – 03FFFFh	000000h – 07FFFFh
1	**1**	**0**	Lower 1/2	000000h – 03FFFFh	000000h – 07FFFFh	000000h – 0FFFFFh
1	**1**	**1**	All	000000h – 07FFFFh	000000h – 0FFFFFh	000000h – 1FFFFFh

Table 15: Write Protection Modes

WREN (Status Register)	WP#EN (Status Register)	WP# (Pin)	Status & Configuration Registers	Memory[1] Array Protected Area	Memory[1] Array Unprotected Area
0	**X**	**X**	Protected	Protected	Protected
1	**0**	**X**	Unprotected	Protected	Unprotected
1	**1**	**Low**	Protected	Protected	Unprotected
1	**1**	**High**	Unprotected	Protected	Unprotected

Notes:
High: Logic '1'
Low: Logic '0'
X: Don't Care – Can be Logic '0' or '1'
Protected: Write protected
Unprotected: Writable
1: Memory address range protection based on Block Protection Bits

12.2 Augmented Storage Array Protection Register (Read/Write)

Augmented Storage Array Protection register contains options for enabling/disabling data protection for eight 32-byte sections.

Table 16: Augmented Storage Array Protection Register – Read and Write

Bits	Name	Description	Read / Write	Default State	Selection Options
ASP[7]	ASPS[7]	ASA Section 7 Write Protection Enable/Disable	R/W	0	1: Protection Enabled 0: Protection Disabled
ASP[6]	ASPS[6]	ASA Section 6 Write Protection Enable/Disable	R/W	0	1: Protection Enabled 0: Protection Disabled
ASP[5]	ASPS[5]	ASA Section 5 Write Protection Enable/Disable	R/W	0	1: Protection Enabled 0: Protection Disabled
ASP[4]	ASPS[4]	ASA Section 4 Write Protection Enable/Disable	R/W	0	1: Protection Enabled 0: Protection Disabled
ASP[3]	ASPS[3]	ASA Section 3 Write Protection Enable/Disable	R/W	0	1: Protection Enabled 0: Protection Disabled
ASP[2]	ASPS[2]	ASA Section 2 Write Protection Enable/Disable	R/W	0	1: Protection Enabled 0: Protection Disabled
ASP[1]	ASPS[1]	ASA Section 1 Write Protection Enable/Disable	R/W	0	1: Protection Enabled 0: Protection Disabled
ASP[0]	ASPS[0]	ASA Section 0 Write Protection Enable/Disable	R/W	0	1: Protection Enabled 0: Protection Disabled

12.3 Device Identification Register (Read Only)

Device identification register contains Avalanche's Manufacturing ID along with device configuration information.

Table 17: Device Identification Register – Read Only

Bits	Avalanche Manufacturer's ID	Device Configuration				
ID[31:0]	ID[31:24]	Interface	Voltage	Temp	Density	Freq
		ID[23:20]	ID[19:16]	ID[15:12]	ID[11:8]	ID[7:0]

Manufacturer ID	Interface	Voltage	Temperature	Density	Frequency
31-24	23-20	19-16	15-12	11-8	7-0
1110 0110	0000-HP QSPI	0001 - 3V	0000 - -40ºC- 85ºC	0010 - 4Mb	00000001 - 108MHz
		0010 - 1.8V	0001 - -40ºC-105ºC	0011 - 8Mb	00000010 – 54MHz
				0100 - 16Mb	00000011 - Reserved
					00000100 - Reserved
					00000101 - Reserved

12.4 Serial Number Register (Read/Write)

Serial Number register is user writable.

Table 18: Serial Number Register – Read and Write

Bits	Name	Description	Read / Write	Default State [1]	Selection Options
SN[63:0]	SN	Serial Number Value	R/W	0000000000000000h	Value stored is based on the customer

Notes:
1: The default value is how the device is shipped from the factory.

12.5 Unique Identification Register (Read Only)

Unique Identification register contains a number unique to every device.

Table 19: Unique ID Register – Read Only

Bits	Name	Description	Read / Write	Selection Options
UID[63:0]	UID	Unique Identification Number Value	R	Value stored is written in the factory and is device specific

12.6 Configuration Register 1 (Read/Write)

Configuration Register 1 controls locking/unlocking data protection options set in the Status register. Once locked, the protection options cannot be changed in the Status register.

Table 20: Configuration Register 1 – Read and Write

Bits	Name	Description	Read / Write	Default State	Selection Options
CR1[7]	RSVD	Reserved	R	0	Reserved for future use
CR1[6]	RSVD	Reserved	R	0	Reserved for future use
CR1[5]	RSVD	Reserved	R	0	Reserved for future use
CR1[4]	RSVD	Reserved	R	0	Reserved for future use
CR1[3]	RSVD	Reserved	R	0	Reserved for future use
CR1[2]	MAPLK	Status Register Lock Enable/Disable (TBSEL, BPSEL[2:0]	R/W	0	1: Lock TBSEL and BPSEL[2:0] 0: Unlock TBSEL and BPSEL[2:0]
CR1[1]	RSVD	Reserved	R	0	Reserved for future use
CR1[0]	ASPLK	Augmented Storage Array Data Protection	R/W	0	1: Write Protect Augmented Storage Array 0: Not Write Protect Augmented Storage Array

12.7 Configuration Register 2 (Read/Write)

Configuration Register 2 controls the interface type along with memory array access latency.

Table 21: Configuration Register 2 – Read and Write

Bits	Name	Description	Read / Write	Default State	Selection Options
CR2[7]	RSVD	Reserved	R	0	Reserved for future use
CR2[6]	QPISL	Quad SPI (QPI 4-4-4) Interface Mode Enable/Disable	R[2]	0	1: Quad SPI (QPI 4-4-4) Enabled 0: Single SPI (SPI 1-1-1) Enabled
CR2[5]	RSVD	Reserved	R	0	Reserved for future use
CR2[4]	DPISL	Dual SPI (DPI 2-2-2) Interface Mode Enable/Disable	R[2]	0	1: Dual SPI (DPI 2-2-2) Enabled 0: Single SPI (SPI 1-1-1) Enabled
CR2[3]	MLATS[3]	Memory Array Read Latency Selection [1]	R/W	0	0000: 0 Cycles - Default 0001: 1 Cycle 0010: 2 Cycles 0011: 3 Cycles 0100: 4 Cycles 0101: 5 Cycles 0110: 6 Cycles 0111: 7 Cycles 1000: 8 Cycles 1001: 9 Cycle 1010: 10 Cycles 1011: 11 Cycles 1100: 12 Cycles 1101: 13 Cycles 1110: 14 Cycles 1111: 15 Cycles
CR2[2]	MLATS[2]			0	
CR2[1]	MLATS[1]			0	
CR2[0]	MLATS[0]			0	

Notes:
1: Latency is frequency dependent. Please consult Table 22 and Table 23.
2: These interface options can only be set through instructions.

Table 22: Memory Array Read Latency Cycles vs. Maximum Clock Frequency (with XIP)

Read Type	Latency	Max Frequency	
		Mxxxx2x108xx	Mxxxx2x054xx
(1-1-1) SDR	8-15	108MHz	54MHz
(1-1-1) DDR		54MHz	27MHz
(1-1-2) SDR		108MHz	54MHz
(1-2-2) SDR		108MHz	54MHz
(2-2-2) SDR		108MHz	54MHz
(2-2-2) DDR		54MHz	27MHz
(1-1-4) SDR	12-15	108MHz	54MHz
(1-4-4) SDR		108MHz	54MHz
(1-4-4) DDR		54MHz	27MHz
(4-4-4) SDR		108MHz	
			54MHz
(4-4-4) DDR		54MHz	27MHz

Table 23: Memory Read Latency Cycles vs. Maximum Clock Frequency (without XIP)

Read Type	Latency	Max Frequency	
		Mxxxx2x108xx	Mxxxx2x054xx
(1-1-1) SDR	0	50MHz	40MHz

Table 24: Augmented Storage Array Read Latency Cycles vs. Maximum Clock Frequency

Read Type	Latency	Max Frequency	
		Mxxxx2x108xx	Mxxxx2x054xx
(1-1-1) SDR	8-15	50MHz	40MHz

Table 25: Read Any Register Command Latency Cycles vs. Maximum Clock Frequency

Read Type	Max Frequency	Latency Cycles
(1-1-1) SDR	108MHz	8
(2-2-2) SDR	108MHz	4
(4-4-4) SDR	108MHz	2

12.8 Configuration Register 3 (Read/Write)

Configuration Register 3 controls the output driver strength along with read data wrap selection.

Table 26: Configuration Register 3 – Read and Write

Bits	Name	Description	Read / Write	Default		Selection Options
				1.8V	3.0V	
CR3[7]	ODSEL[2]	Output Driver Strength Selector	R/W	0	0	1.8V / 3.0V 000: 45Ω[1] / 35Ω 001: 120Ω / 75Ω 010: 90Ω / 60Ω 011: 70Ω / 45Ω[1] 100: 45Ω / 35Ω 101: 60Ω / 40Ω 110: 30Ω / 20Ω 111: 20Ω / 15Ω
CR3[6]	ODSEL[1]			0	1	
CR3[5]	ODSEL[0]			0	1	
CR3[4]	WRAPS	Read WRAP Enable / Disable (16/32/64/128/256 Byte)	R/W	0		1: Read Data Wrap Enabled 0: Read Data Wrap Disabled
CR3[3]	RSVD	Reserved	R	0		Reserved for future use
CR3[2]	WRPLS[2]	Wrap Length Selector[2]	R/W	0		000: 16-byte Boundary 001: 32-byte Boundary 010: 64-byte Boundary 011: 128-byte Boundary 100: 256-byte Boundary 101: Reserved 110: Reserved 111: Reserved
CR3[1]	WRPLS[1]			0		
CR3[0]	WRPLS[0]			0		

Notes:
1: Default Setting (V_{CC} dependent).
2: If Wrap is enabled, the read data wraps within an aligned 16/32/64/128/256-byte boundary at any address. The starting address entered selects the group of bytes and the first data returned is the addressed byte. Bytes are then read sequentially until the end of the group boundary is reached. If read continues, the address wraps to the beginning of the group and continues to read sequentially.

12.9 Configuration Register 4 (Read/Write)

Configuration Register 4 controls Write Enable protection (WREN – Status Register) reset functionality during memory array writing[1]. This functionality makes SPI MRAM compatible to other SPI devices.

Table 27: Configuration Register 4 – Read and Write

Bits	Name	Description	Read / Write	Default State	Selection Options
CR4[7]	RSVD	Reserved	R/W	0	Reserved for future use
CR4[6]	RSVD	Reserved		0	Reserved for future use
CR4[5]	RSVD	Reserved		0	Reserved for future use
CR4[4]	RSVD	Reserved		0	Reserved for future use
CR4[3]	RSVD	Reserved		0	Reserved for future use
CR4[2]	RSVD	Reserved		1	Reserved[2]
CR4[1]	WRENS[1]	WREN Reset Selector (Memory & Augmented Storage Array Write Functionality)		0	00: Normal: WREN is prerequisite to all Memory Array Write instruction. (WREN is reset after CS# goes High) 01: SRAM: WREN is not a prerequisite to Memory Array Write instruction (WREN is ignored) 10: Back-to-Back: WREN is prerequisite to only the first Memory Array Write instruction. WREN disable instruction must be executed to reset WREN. (WREN does not reset once CS# goes High) 11: Illegal - Reserved for future use
CR4[0]	WRENS[0]			1	

Notes:
1: Write Enable protection (WREN – Status Register) for Registers is maintained irrespective of the Configuration Register 4 settings. In other words, all register write instructions require WREN to be set and WREN resets once CS# goes High for the write instruction.
2: Must be set to "1". Writing a "0" to this bit may impact device functionality.

13. Instruction Set

Table 28: Instruction Set

#	Instruction Name	Command (Opcode)	(1-0-0)	(1-0-1)	(1-1-1)	(1-1-2)	(1-2-2)	(2-0-0)	(2-0-2)	(2-2-2)	(1-1-4)	(1-4-4)	(4-0-0)	(4-0-4)	(4-4-4)	XIP	SDR	DDR	Latency Cycles	Data Bytes	Max. Frequency	Prerequisite
Control Instructions																						
1	**No Operation**	NOOP 00h	•					•					•				•				108 MHz	
2	**Write Enable**	WREN 06h	•					•					•				•				108 MHz	
3	**Write Disable**	WRDI 04h	•					•					•				•				108 MHz	
4	**Enable DPI**	DPIE 37h	•										•				•				108 MHz	
5	**Enable QPI**	QPIE 38h	•					•									•				108 MHz	
6	**Enable SPI**	SPIE FFh						•					•				•				108 MHz	
7	**Enter Deep Power Down**	DPDE B9h	•					•					•				•				108 MHz	
8	**Enter Hibernate**	HBNE BAh	•					•					•				•				108 MHz	
9	**Software Reset Enable**	SRTE 66h	•					•					•				•				108 MHz	
10	**Software Reset**	SRST 99h	•					•					•				•				108 MHz	SRTE
11	**Exit Deep Power Down**	DPDX ABh	•					•					•				•				108 MHz	
Read Register Instructions																						
12	**Read Status Register**	RDSR 05h		•					•					•			•			1	54 MHz	
13	**Read Configuration Register 1**	RDC1 35h		•					•					•			•			1	54 MHz	
14	**Read Configuration Register 2**	RDC2 3Fh		•					•					•			•			1	54 MHz	
15	**Read Configuration Register 3**	RDC3 44h		•					•					•			•			1	54 MHz	
16	**Read Configuration Register 4**	RDC4 45h		•					•					•			•			1	54 MHz	
17	**Read Configuration Register 1, 2, 3, 4**	RDCX 46h		•					•					•			•			4	54 MHz	
18	**Read Device ID**	RDID 9Fh		•					•					•			•			4	54 MHz	
19	**Read Unique ID**	RUID 4Ch		•					•					•			•			8	54 MHz	

#	Instruction Name	Command (Opcode)	(1-0-0)	(1-0-1)	(1-1-1)	(1-1-2)	(1-2-2)	(2-0-0)	(2-0-2)	(2-2-2)	(1-1-4)	(1-4-4)	(4-0-0)	(4-0-4)	(4-4-4)	XIP	SDR	DDR	Latency Cycles	Data Bytes	Max. Frequency	Prerequisite
20	**Read Serial Number Register**	RDSN C3h		•					•					•			•			8	54 MHz	
21	**Read Augmented Array Protection Register**	RDAP 14h		•					•					•			•			1	54 MHz	
22	**Read Any Register - Address Based**	RDAR 65h			•					•					•		•		•	1 to 8	108 MHz	
	Write Register Instructions																					
23	**Write Status Register**	WRSR 01h		•					•					•			•			1	108 MHz	WREN
24	**Write Configuration Registers 1, 2, 3, 4**	WRCX 87h		•					•					•			•			4	108 MHz	WREN
25	**Write Serial Number Register**	WRSN C2h		•					•					•			•			8	108 MHz	WREN
26	**Write Augmented Array Protection Register**	WRAP 1Ah		•					•					•			•			1	108 MHz	WREN
27	**Write Any Register - Address Based**	WRAR 71h			•					•					•		•			1 to 8	108 MHz	WREN
	Read Memory Array Instructions																					
28	**Read Memory Array - SDR**	READ 03h			•												•			1 to ∞	50 MHz	
29	**Fast Read Memory Array - SDR**	RDFT 0Bh			•					•					•	•	•		•	1 to ∞	108 MHz	
30	**Fast Read Memory Array - DDR**	DRFR 0Dh			•					•					•	•		•	•	1 to ∞	54 MHz	
31	**Read Dual Output Memory Array - SDR**	RDDO 3Bh				•										•	•		•	1 to ∞	108 MHz	
32	**Read Quad Output Memory Array - SDR**	RDQO 6Bh									•					•	•		•	1 to ∞	108 MHz	
33	**Read Dual I/O Memory Read - SDR**	RDDI BBh					•									•	•		•	1 to ∞	108 MHz	
34	**Read Dual I/O Memory Read - DDR**	DRDI BDh					•									•		•	•	1 to ∞	54 MHz	
35	**Read Quad I/O Memory Read - SDR**	RDQI EBh										•				•	•		•	1 to ∞	108 MHz	
36	**Read Quad I/O Memory Read - DDR**	DRQI EDh										•				•		•	•	1 to ∞	54 MHz	
	Write Memory Array Instructions																					
37	**Write Memory Array - SDR**	WRTE 02h			•												•			1 to ∞	108 MHz	WREN
38	**Fast Write Memory Array - SDR**	WRFT DAh			•					•					•	•	•			1 to ∞	108 MHz	WREN
39	**Fast Write Memory Array - DDR**	DRFW DEh			•					•					•	•		•		1 to ∞	54 MHz	WREN

#	Instruction Name	Command (Opcode)	(1-0-0)	(1-0-1)	(1-1-1)	(1-1-2)	(1-2-2)	(2-0-0)	(2-0-2)	(2-2-2)	(1-1-4)	(1-4-4)	(4-0-0)	(4-0-4)	(4-4-4)	XIP	SDR	DDR	Latency Cycles	Data Bytes	Max. Frequency	Prerequisite
40	**Write Dual Input Memory Array - SDR**	WDUI A2h				•										•	•			1 to ∞	108 MHz	WREN
41	**Write Quad Input Memory Array - SDR**	WQDI 32h									•					•	•			1 to ∞	108 MHz	WREN
42	**Write Quad Input Memory Array - DDR**	DWQI 31h									•					•		•		1 to ∞	54 MHz	WREN
43	**Write Dual I/O Memory Array - SDR**	WDIO A1h					•									•	•			1 to ∞	108 MHz	WREN
44	**Write Quad I/O Memory Array - SDR**	WQIO D2h										•				•	•			1 to ∞	108 MHz	WREN
45	**Write Quad I/O Memory Array - DDR**	DWQO D1h										•				•		•		1 to ∞	54 MHz	WREN
Augmented Storage Array Instructions																						
46	**Read Augmented Storage Array - SDR**	RDAS 4Bh			•												•		•	1 to 256	50 MHz	
47	**Write Augmented Storage Array - SDR**	WRAS 42h			•												•			1 to ∞	108 MHz	WREN

Notes:
1: A typical SPI instruction consists of command, address and data components. The bus width to transmit these three components varies based on the SPI interface mode selected. To accurately represent the number of I/Os used to transmit these three components, a nomenclature (command-address-data) is adopted and used throughout this document. Integers placed in the (command-address-data) fields represent the number of I/Os used to transmit the particular component. As an example, 1-1-1 means command, address and data are transmitted on a single I/O (SI / IO[0] or SO / IO[1]). On the other hand, 1-4-4 represents command being sent on a single I/O (SI / IO[0]) and address/data being sent on four I/Os (IO[3:0]).
2: XIP allows completing a series of read and write instructions without having to individually load the read or write command for each instruction. A special mode byte must be entered after the address bits to enable/disable XIP – Axh / Fxh.
3: Read instruction must include Latency cycles to meet higher frequency. They are configurable (Configuration Register 2 – CR2[3:0]) and frequency dependent.
4: The augmented storage array is 256-Bytes in size. The address bits ADDR[23:8] must be Logic '0' for this instruction.
5: Registers do not wrap data during reads. Reading beyond the specified number of bytes will yield indeterminate data.
6: WREN prerequisite for array writing is configurable (Configuration Register 4 – CR4[1:0]).
7: For the Exit Deep Power Down command, the maximum frequency is 108MHz for 1-1-1 operation and 36MHz for 2-2-2 and 4-4-4 operations.

14. Instruction Description and Structures

All communication between a host and Mxxxx204 is in the form of instructions. Instructions define the operation that must be executed. Instructions consist of a command followed by an optional address modifier and data transfer to or from Mxxxx204. All command, address and data information is transferred sequentially. Instructions are structured as follows:

- *Each instruction begins with CS# going Low (logic '0') and ends with CS# returning High (Logic'1').*
- *CLK marks the transfer of each bit.*
- *Each instructions starts out with an 8-bit command. The command selects the type of operation Mxxxx204 must perform. The command is transferred on the rising edges of CLK.*
- *The command can be stand alone or followed by address to select a memory location or register. The address is always 24-bits wide.*
  - *SDR: The address is transferred on the rising edges of CLK.*
  - *DDR: The address is transferred on both edges of the CLK in DDR.*
- *The address bits are followed by data bits. For Write instructions:*
  - *SDR: Write data bits to Mxxxx204 are transferred on the rising edges of CLK.*
  - *DDR: Write data bits to Mxxxx204 are transferred on both edges of CLK.*
- In normal operational mode, Write instructions must be preceded by the WREN instruction. WREN instruction sets the WREN bit in the Status register. WREN bit is reset at the end of every Write instruction. WREN bit can also be reset by executing the WRDI instruction. Mxxxx204 offers two other modes, namely SRAM and Back-to-Back Write where WREN does not get reset after a write instruction to the memory array or the augmented storage array. These modes are set in Configuration Register 4.
- *Similar to write instructions, the address bits are followed by data bits for read instructions:*
  - *SDR: Read data bits from Mxxxx204 are transferred on the falling edges of CLK.*
  - *DDR: Read data bits from Mxxxx204 are transferred on both edges of CLK. The start of read data transfer is always on the falling edge of the CLK.*
- *Mxxxx204 is a high performance serial memory and at higher frequencies, read instructions require latency cycles to compensate for the memory array access time. The number of latency cycles required depends on the operational frequency and is configurable – Configuration Register 2. The latency cycles are inserted after the address bits before the data comes out of Mxxxx204.*
- *For Read and Write instructions, Mxxxx204 offers XIP mode. XIP allows similar instructions to be executed sequentially without incurring the command cycles overhead. XIP is enabled by entering byte Axh and disabled by entering byte Fxh. These respective bytes must be entered following the address bits.*
- For Read instructions, Mxxxx204 offers wrap mode. Wrap bursts are confined to address aligned 16/32/64/128/256 byte boundary. The read address can start anywhere within the wrap boundary. 16/32/64/128/256 wrap configuration is set in Configuration Register 3.
- *The entire memory array can be read from or written to using a single read or write instruction. After the staring address is entered, subsequent address are internally incremented as long as CS# is Low and CLK continues to cycle.*
- *All commands, address and data are shifted with the most significant bit first.*

Figure 8 to ***Figure 24*** show the description of SDR instruction types supported.

Figure 8: Description of (1-0-0) Instruction Type

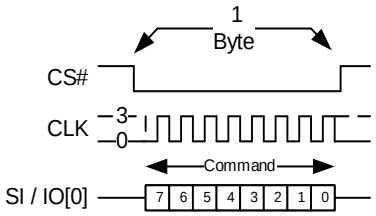


Figure 9: Description of (1-0-1) Instruction Type

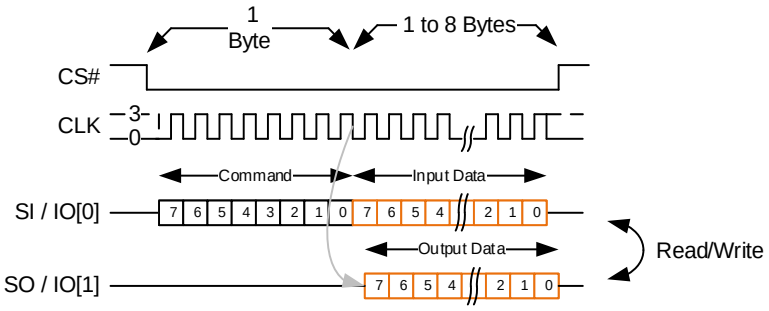


Figure 10: Description of (1-1-1) Instruction Type (Without XIP)

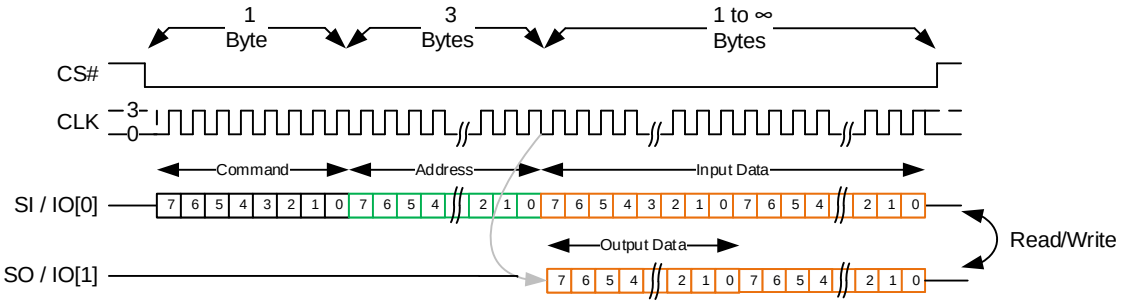


Figure 11: Description of (1-1-1) Augmented Storage Instruction Type

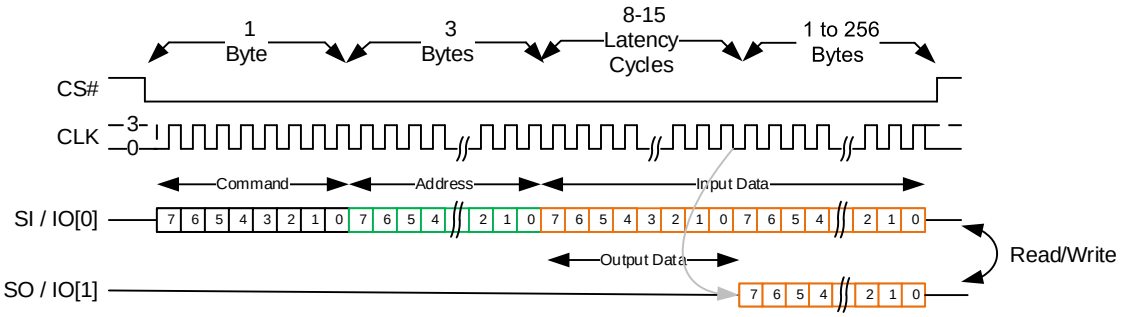


Figure 12: Description of (1-1-1) Instruction Type (With XIP)

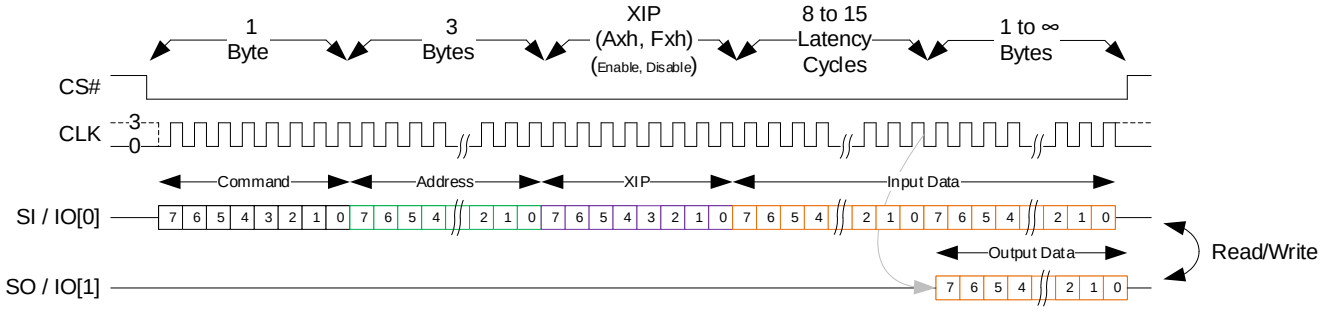


Figure 13: Description of (1-1-2) Instruction Type (With XIP)

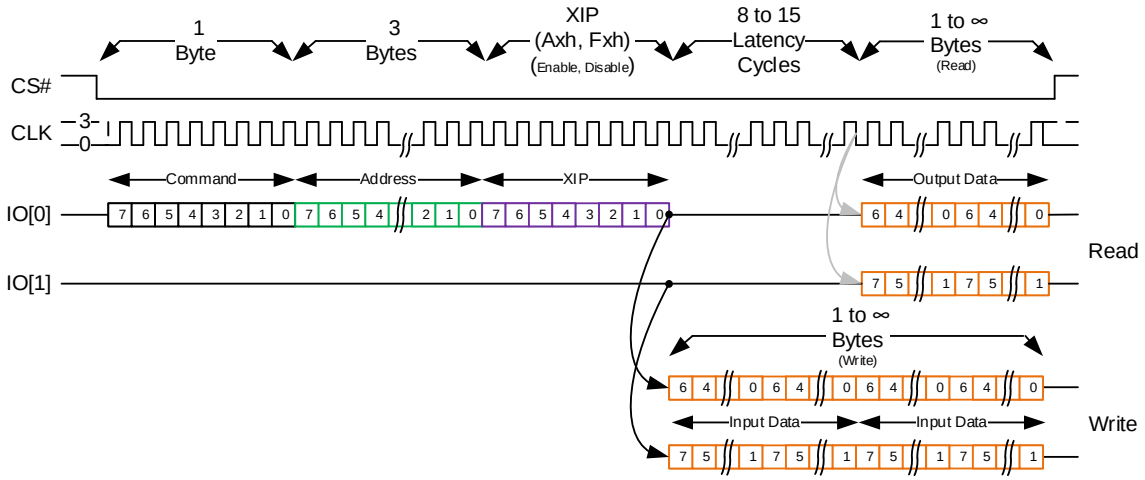


Figure 14: Description of (1-2-2) Instruction Type (With XIP)

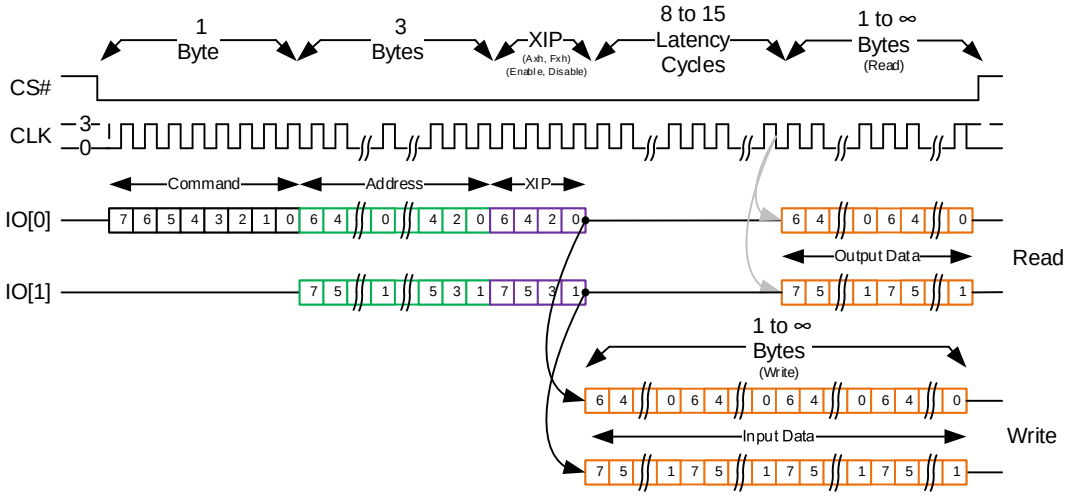


Figure 15: Description of (2-0-0) Instruction Type

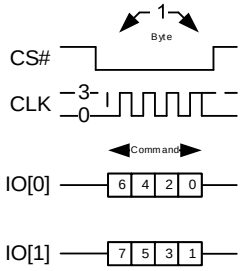


Figure 16: Description of (2-0-2) Instruction Type

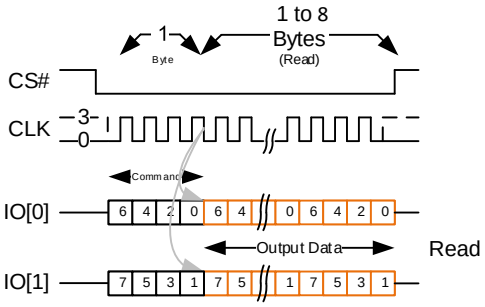


Figure 17: Description of (2-2-2) Any Register Instruction Type

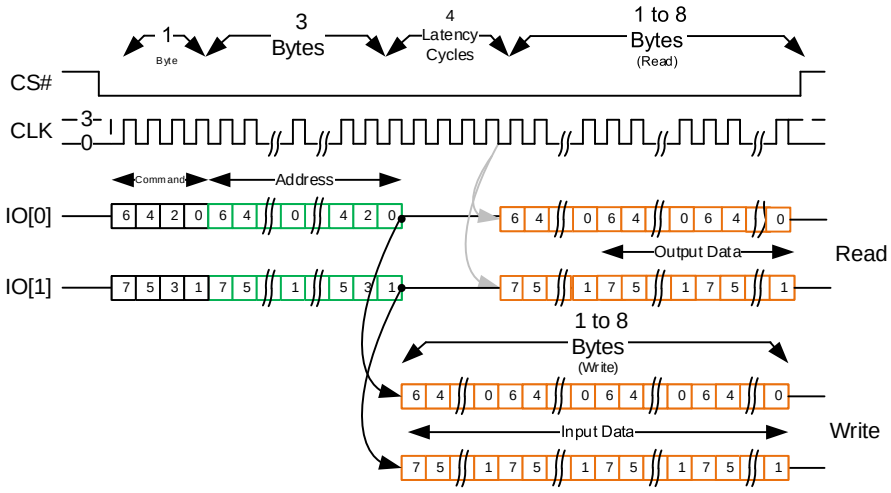


Figure 18: Description of (2-2-2) Instruction Type (With XIP)

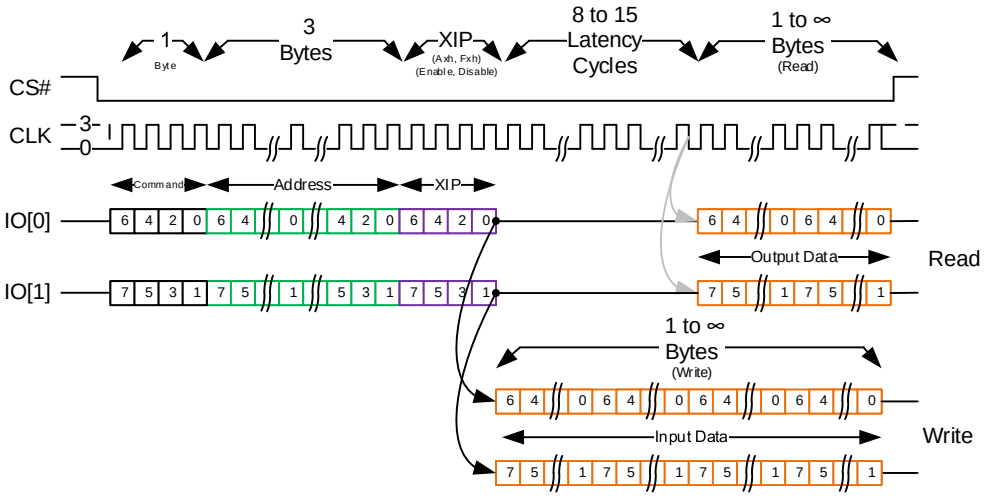


Figure 19: Description of (1-1-4) Instruction Type (With XIP)

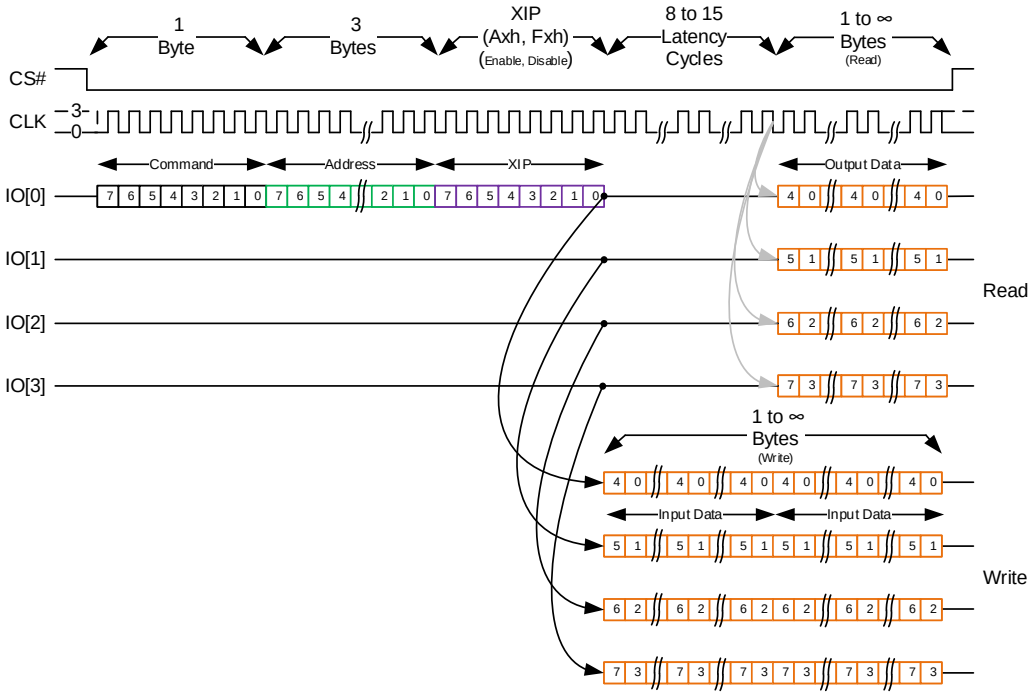


Figure 20: Description of (1-4-4) Instruction Type (With XIP)

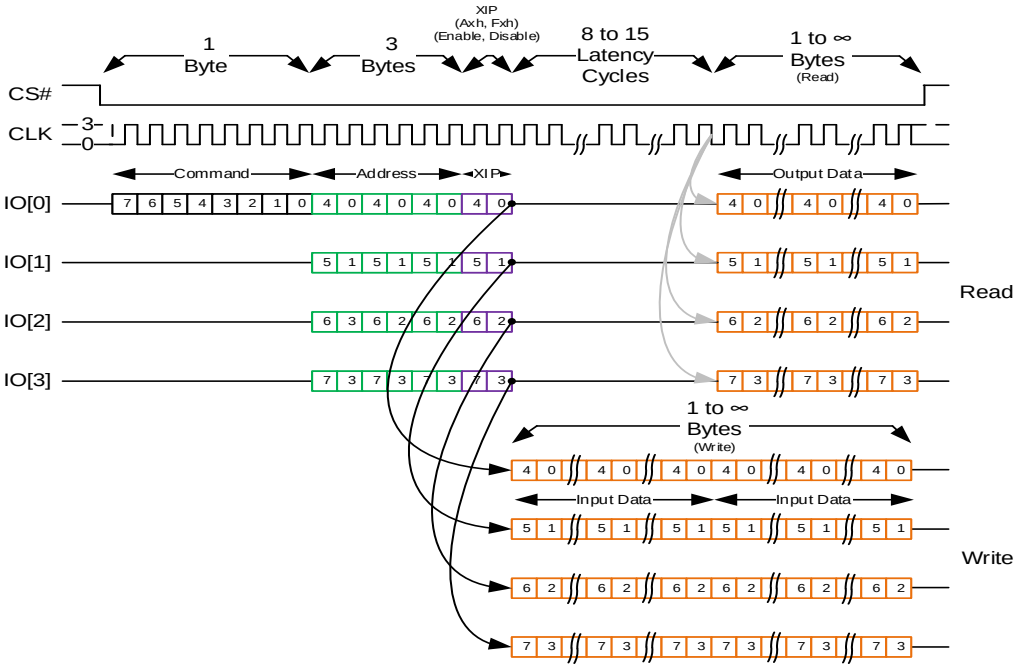


Figure 21: Description of (4-0-0) Instruction Type

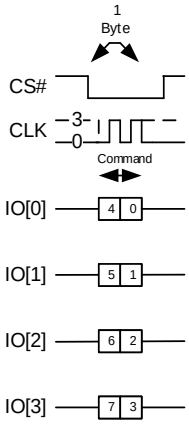


Figure 22: Description of (4-0-4) Instruction Type

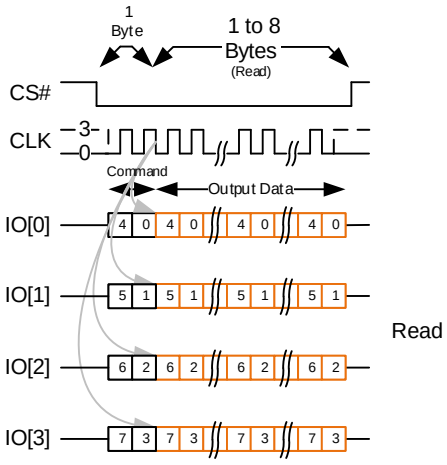


Figure 23: Description of (4-4-4) Any Register Instruction Type (Without XIP)

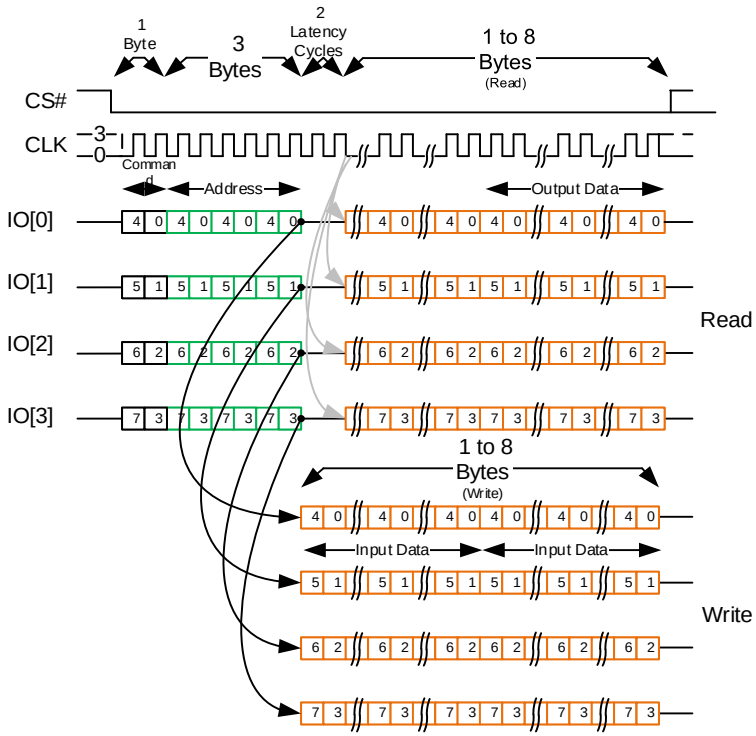


Figure 24: Description of (4-4-4) Instruction Type (With XIP)

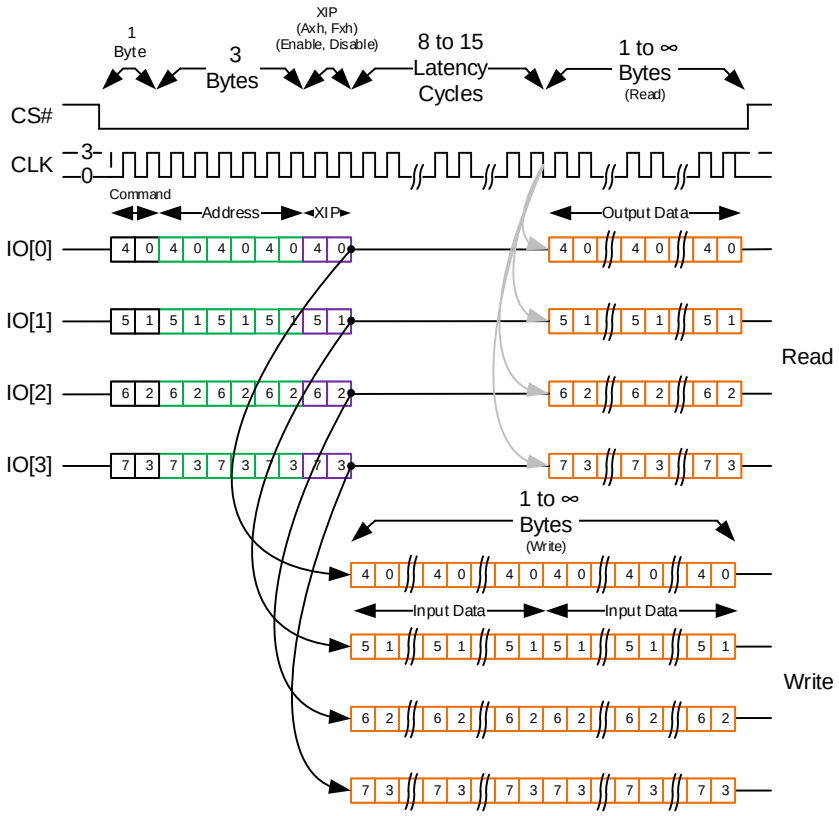


***Figure* 25** to ***Figure* 29** show the description of DDR instruction types supported.

Figure 25: Description of (1-1-1) DDR Instruction Type (With XIP)

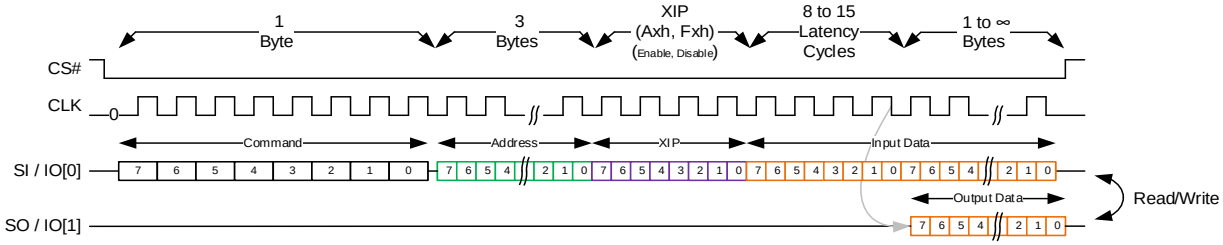


Figure 26: Description of (2-2-2) DDR Instruction Type (With XIP)

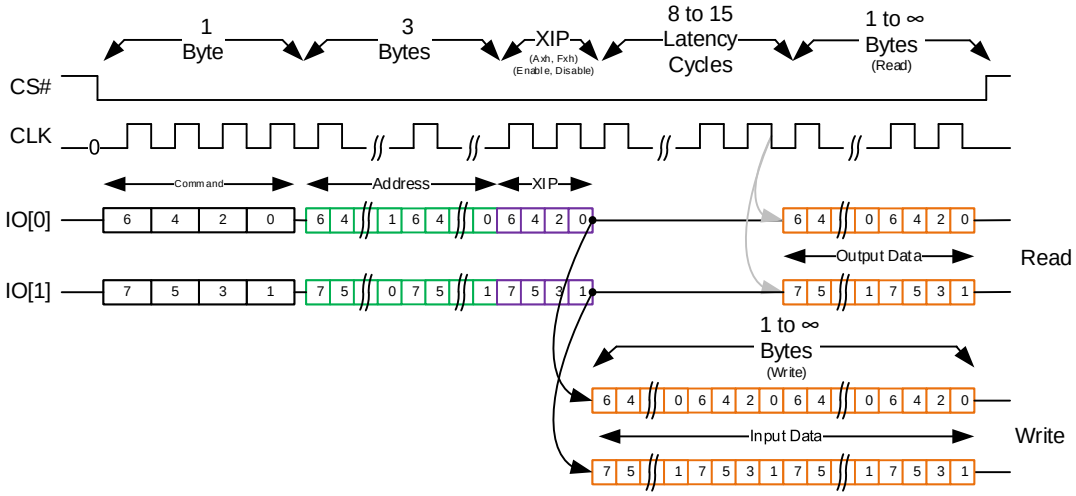


Figure 27: Description of (4-4-4) DDR Instruction Type (With XIP)

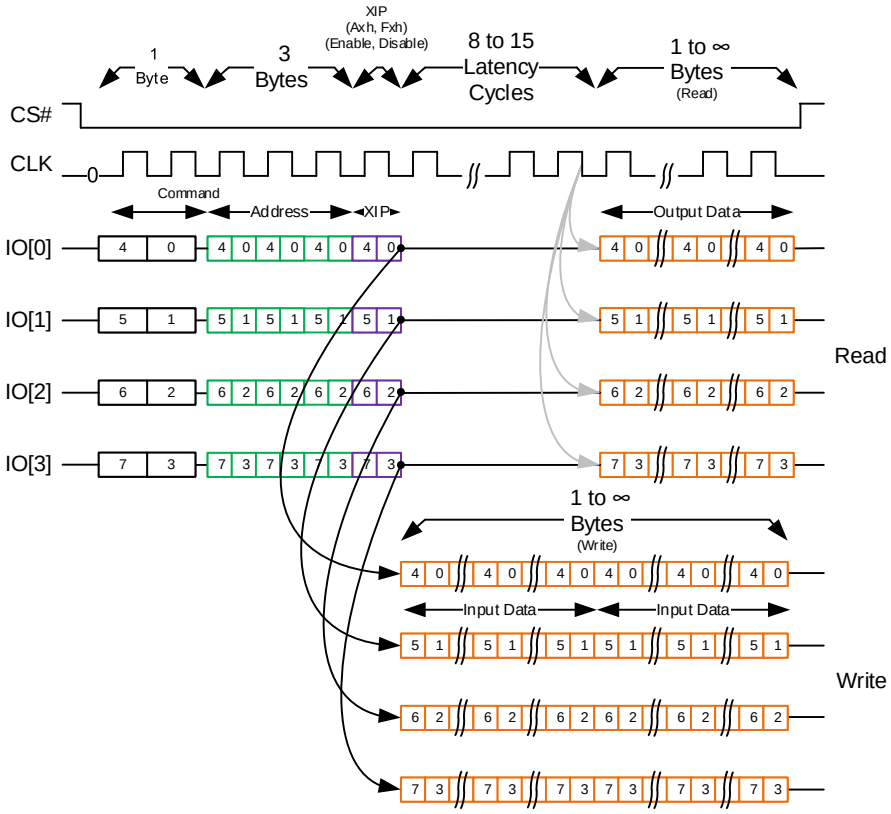


Figure 28: Description of (1-2-2) DDR Instruction Type (With XIP)

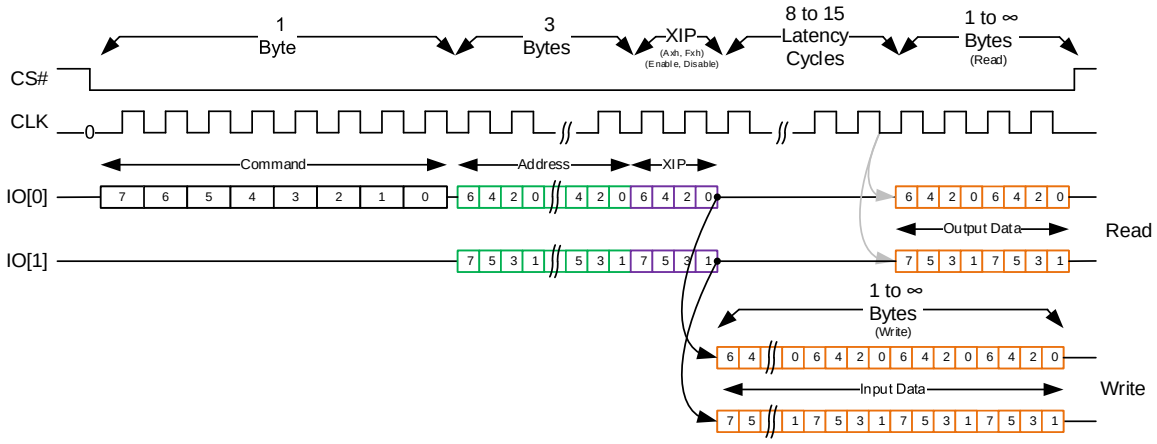
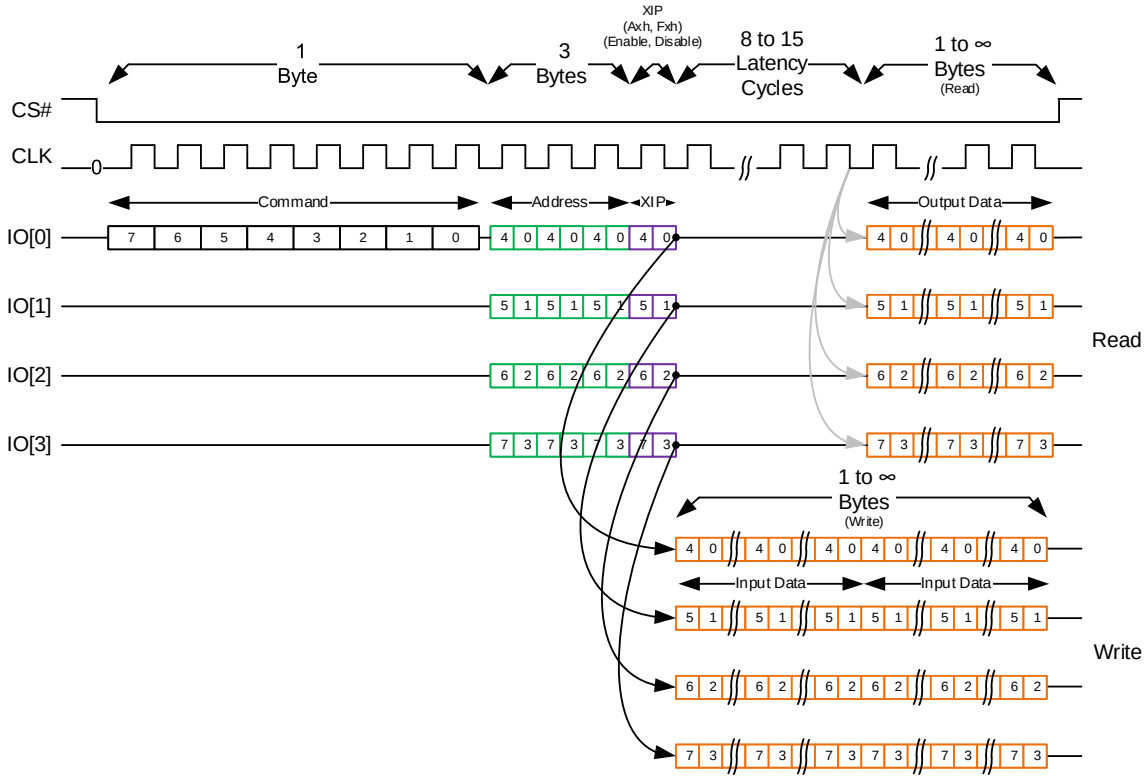


Figure 29: Description of (1-4-4) DDR Instruction Type (With XIP)



15. Electrical Specifications

Table 29: Recommended Operating Conditions

Parameter / Condition		Minimum	Typical	Maximum	Units
Operating Temperature	Industrial	-40.0	-	85.0	°C
	Industrial Plus	-40.0	-	105.0	°C
V_{CC} Supply Voltage (3.0V)	3.0V	2.7	3.0	3.6	V
V_{CC} Supply Voltage (1.8V)	1.8V	1.71	1.8	2.0	V
V_{SS} Supply Voltage		0.0	0.0	0.0	V

Table 30: Pin Capacitance

Parameter	Test Conditions	Symbol	Maximum	Units
Input Pin Capacitance	TEMP = 25°C; f = 1 MHz; V_{IN} = 3.0V	C_{IN}	5.0	pF
Output Pin Capacitance	TEMP = 25°C; f = 1 MHz; V_{IN} = 3.0V	C_{INOUT}	6.0	pF

Table 31: Endurance & Retention

Parameter	Symbol	Test Conditions	Minimum	Units
Write Endurance	END	-	10^{14}	cycles
Data Retention	RET	105°C	10	years
		85°C	1,000	
		75°C	10,000	
		65°C	1,000,000	

Table 32: 3.0V DC Characteristics

Parameter	Symbol	Test Conditions	3.0V Device (2.7V-3.6V)			
			Minimum	Typical	Maximum	Units
Read Current (1-1-1) SDR	I_{READ1}	V_{CC} = 3.6V, I_{OUT}=0mA, CLK=54MHz (V_{IL} / V_{IH}), CS#= V_{IL}, SI= V_{IL} or V_{IH}	-	8	9	mA
Read Current (2-2-2) SDR	I_{READ2}		-	9	10	mA
Read Current (4-4-4) SDR	I_{READ3}		-	10	12	mA
Read Current (1-1-1) SDR	I_{READ4}	V_{CC} = 3.6V, I_{OUT}=0mA, CLK=108MHz (V_{IL} / V_{IH}), CS#= V_{IL}, SI= V_{IL} or V_{IH}	-	13	15	mA
Read Current (2-2-2) SDR	I_{READ5}		-	15	17	mA
Read Current (4-4-4) SDR	I_{READ6}		-	19	21	mA
Read Current (1-1-1) DDR	I_{READ7}	V_{CC} = 3.6V, I_{OUT}=0mA, CLK=54MHz (V_{IL} / V_{IH}), CS#= V_{IL}, SI= V_{IL} or V_{IH}	-	13	18	mA
Read Current (2-2-2) DDR	I_{READ8}		-	20	24	mA
Read Current (4-4-4) DDR	I_{READ9}		-	23	28	mA
Write Current (1-1-1) SDR	I_{WRITE1}	V_{CC} = 3.6V, I_{OUT}=0mA, CLK=54MHz (V_{IL} / V_{IH}), CS#= V_{IL}, SI= V_{IL} or V_{IH}	-	14	16	mA
Write Current (2-2-2) SDR	I_{WRITE2}		-	17	20	mA
Write Current (4-4-4) SDR	I_{WRITE3}		-	22	25	mA

Parameter	Symbol	Test Conditions		3.0V Device (2.7V-3.6V)			
				Minimum	Typical	Maximum	Units
Write Current (1-1-1) SDR	I_{WRITE4}	V_{CC} = 3.6V, I_{OUT}=0mA, CLK=108MHz (V_{IL} / V_{IH}), CS#= V_{IL}, SI= V_{IL} or V_{IH}		-	22	28	mA
Write Current (2-2-2) SDR	I_{WRITE5}			-	25	32	mA
Write Current (4-4-4) SDR	I_{WRITE6}			-	38	45	mA
Write Current (1-1-1) DDR	I_{WRITE7}	V_{CC} = 3.6V, I_{OUT}=0mA, CLK=54MHz (V_{IL} / V_{IH}), CS#= V_{IL}, SI= V_{IL} or V_{IH}		-	15	25	mA
Write Current (2-2-2) DDR	I_{WRITE8}			-	20	30	mA
Write Current (4-4-4) DDR	I_{WRITE9}			-	30	45	mA
Standby Current	I_{SB}	V_{CC} = 3.6V, CLK=V_{CC}, CS#=V_{CC}, SI=V_{CC}	Ta = 25ºC	-	160	-	µA
			Ta = 85ºC	-	-	400	µA
			Ta =105ºC	-	-	600	µA
Deep Power Down Current	I_{DPD}	V_{CC} = 3.6V, CLK=V_{CC}, CS#=V_{CC}, SI=V_{CC}		-	5	25	µA
Hibernate Current	I_{HBN}	V_{CC} = 3.6V, CLK=V_{CC}, CS#=V_{CC}, SI=V_{CC}		-	0.1	-	µA
Input Leakage Current	I_{LI}	V_{IN}=0 to V_{CC} (max)		-	-	±1.0	µA
Output Leakage Current	I_{LO}	V_{OUT}=0 to V_{CC} (max)		-	-	±1.0	µA
Input High Voltage	V_{IH}			0.7xV_{CC}	-	V_{CC}+0.3	V
Input Low Voltage	V_{IL}			-0.3	-	0.3xV_{CC}	V
Output High Voltage Level	V_{OH}	I_{OH} = -100µA		V_{CC}-0.2	-	-	V
		I_{OH} = -1mA		2.4	-	-	V
Output Low Voltage Level	V_{OL}	I_{OL} = 150µA		-	-	0.2	V
		I_{OL} = 2mA		-	-	0.4	V

Table 33: 1.8V DC Characteristics

Parameter	Symbol	Test Conditions	1.8V Device (1.71V-2.0V)			
			Minimum	Typical	Maximum	Units
Read Current (1-1-1) SDR	I_{READ1}	V_{CC} = 2.0V, I_{OUT}=0mA, CLK=54MHz (V_{IL} / V_{IH}), CS#= V_{IL}, SI= V_{IL} or V_{IH}	-	5	8	mA
Read Current (2-2-2) SDR	I_{READ2}		-	6	9	mA
Read Current (4-4-4) SDR	I_{READ3}		-	7	11	mA
Read Current (1-1-1) SDR	I_{READ4}	V_{CC} = 2.0V, I_{OUT}=0mA, CLK=108MHz (V_{IL} / V_{IH}), CS#= V_{IL}, SI= V_{IL} or V_{IH}	-	8	12	mA
Read Current (2-2-2) SDR	I_{READ5}		-	9	13	mA
Read Current (4-4-4) SDR	I_{READ6}		-	12	17	mA
Read Current (1-1-1) DDR	I_{READ7}	V_{CC} = 2.0V, I_{OUT}=0mA, CLK=54MHz (V_{IL} / V_{IH}), CS#= V_{IL}, SI= V_{IL} or V_{IH}	-	11	14	mA
Read Current (2-2-2) DDR	I_{READ8}		-	17	20	mA
Read Current (4-4-4) DDR	I_{READ9}		-	21	25	mA
Write Current (1-1-1) SDR	I_{WRITE1}	V_{CC} = 2.0V, I_{OUT}=0mA, CLK=54MHz (V_{IL} / V_{IH}),	-	13	15	mA
Write Current (2-2-2) SDR	I_{WRITE2}		-	16	19	mA

Parameter	Symbol	Test Conditions		1.8V Device (1.71V-2.0V)			
				Minimum	Typical	Maximum	Units
Write Current (4-4-4) SDR	I_{WRITE3}	CS#= V_{IL}, SI= V_{IL} or V_{IH}		-	20	23	mA
Write Current (1-1-1) SDR	I_{WRITE4}	V_{CC} = 2.0V, I_{OUT}=0mA, CLK=108MHz (V_{IL} / V_{IH}), CS#= V_{IL}, SI= V_{IL} or V_{IH}		-	20	26	mA
Write Current (2-2-2) SDR	I_{WRITE5}			-	23	30	mA
Write Current (4-4-4) SDR	I_{WRITE6}			-	36	43	mA
Write Current (1-1-1) DDR	I_{WRITE7}	V_{CC} = 2.0V, I_{OUT}=0mA, CLK=54MHz (V_{IL} / V_{IH}), CS#= V_{IL}, SI= V_{IL} or V_{IH}		-	13	23	mA
Write Current (2-2-2) DDR	I_{WRITE8}			-	19	28	mA
Write Current (4-4-4) DDR	I_{WRITE9}			-	28	43	mA
Standby Current	I_{SB}	V_{CC} = 2.0V, CLK=V_{CC}, CS#=V_{CC}, SI=V_{CC}	Ta = 25ºC	-	140	-	µA
			Ta = 85ºC	-	-	350	µA
			Ta=105ºC	-	-	500	µA
Deep Power Down Current	I_{DPD}	V_{CC} = 2.0V, CLK=V_{CC}, CS#=V_{CC}, SI=V_{CC}		-	4	20	µA
Hibernate Current	I_{HBN}	V_{CC} = 2.0V, CLK=V_{CC}, CS#=V_{CC}, SI=V_{CC}		-	0.1	-	µA
Input Leakage Current	I_{LI}	V_{IN}=0 to V_{CC} (max)		-	-	±1.0	µA
WP# Leakage Current	$I_{WP\#LI}$	V_{IN}=0 to V_{CC} (max)		-100.0	-	+1.0	µA
Output Leakage Current	I_{LO}	V_{OUT}=0 to V_{CC} (max)		-	-	±1.0	µA
Input High Voltage	V_{IH}			0.7xV_{CC}	-	V_{CC}+0.3	V
Input Low Voltage	V_{IL}			-0.3	-	0.3xV_{CC}	V
Output High Voltage Level	V_{OH}	I_{OH} = -100µA		V_{CC}-0.2	-	-	V
		I_{OH} = -1mA		1.5	-	-	V
Output Low Voltage Level	V_{OL}	I_{OL} = 150µA		-	-	0.2	V
		I_{OL} = 2mA		-	-	0.4	V

Absolute Maximum Ratings

Stresses greater that those listed may cause permanent damage to the device. This is a stress rating only. Exposure to maximum rating for extended periods may adversely affect reliability.

Table *34*:Absolute Maximum Ratings

Parameter	Minimum	Maximum	Units
Magnetic Field During Write	---	24000	A/m
Magnetic Field During Read	---	24000	A/m
Junction Temperature	---	125	°C
Storage Temperature	-55 to 150		°C
ESD HBM (Human Body Model) ANSI/ESDA/JEDEC JS-001-2017	≥ |2000 V|		V
ESD CDM (Charged Device Model) ANSI/ESDA/JEDEC JS-002-2018	≥ |500 V|		V
Latch-Up (I-test) JESD78	≥ |100 mA|		mA
Latch-Up (Vsupply over-voltage test) JESD78	Passed		---

Table 35: AC Test Conditions

Parameter	Value
Input pulse levels	0.0V to V_{CC}
Input rise and fall times	3.0ns
Input and output measurement timing levels	$V_{CC}/2$
Output Load	CL = 30.0pF

15.1 CS# Operation & Timing

Figure 30: CS# Operation & Timing

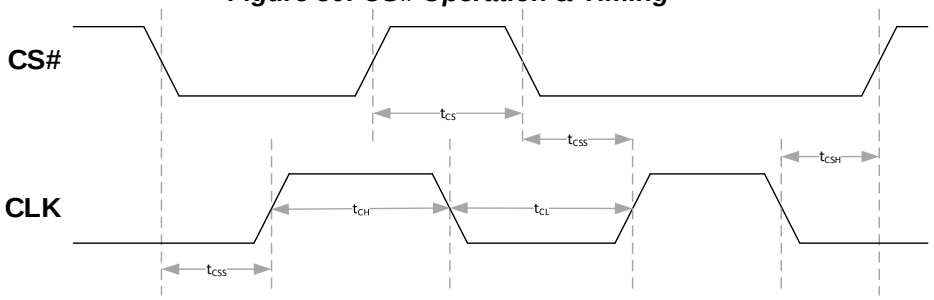


Table *36*: CS# Operation

Parameter	Symbol	Minimum	Maximum	Units
Clock Frequency	f_{CLK}	1	108 (SDR)	MHz
Clock Low Time	t_{CL}	0.45 * 1/ f_{CLK}	-	ns
Clock High Time	t_{CH}	0.45 * 1/ f_{CLK}	-	ns
Chip Deselect Time after Read Cycle	t_{CS1}	20	-	ns
Chip Deselect Time after Register Write Cycle[1]	t_{CS2}	5	-	µs
Chip Deselect Time after Write Cycle (SPI)	t_{CS3}	280	-	ns
Chip Deselect Time after Write Cycle (DPI)	t_{CS4}	350	-	ns
Chip Deselect Time after Write Cycle (QPI)	t_{CS5}	490[2]	-	ns
CS# Setup Time (w.r.t CLK)	t_{CSS}	5	-	ns
CS# Hold Time (w.r.t CLK)	t_{CSH}	4	-	ns

Notes:
Power supplies must be stable
1:SDR operation only
2:For single byte operations, t_{CS5} is 280ns

Command, Address, XIP and Data Input Operation & Timing

Figure 31: SDR Command, Address and Data Input Operation & Timing

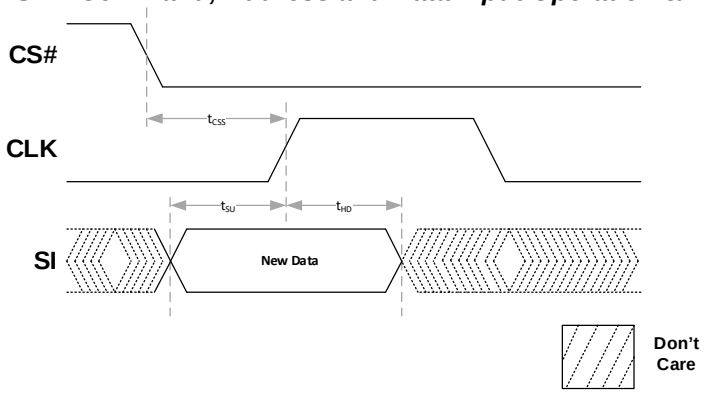


Table 37: SDR Command, Address, XIP, and Data Input Operation & Timing

Parameter	Symbol	Minimum	Maximum	Units
Data Setup Time (w.r.t CLK)	t_{SU}	2.0	-	ns
Data Hold Time (w.r.t CLK)	t_{HD}	3.0	-	ns

Notes:
Power supplies must be stable

Figure 32: DDR Command, Address and Data Input Operation & Timing

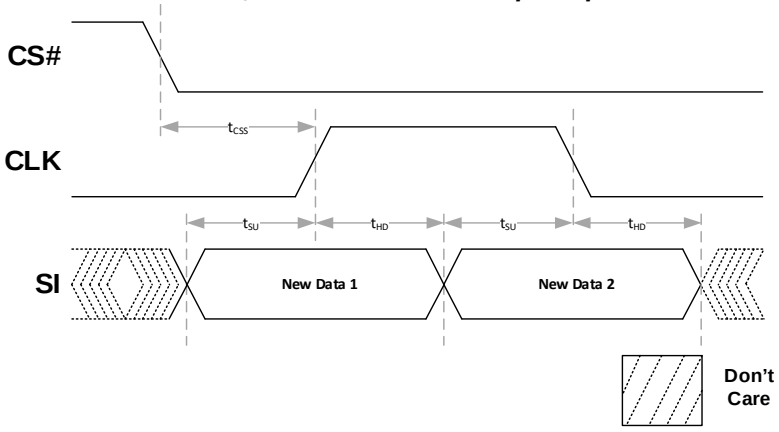


Table 38: DDR Command, Address, XIP, and Data Input Operation & Timing

Parameter	Symbol	Minimum	Maximum	Units
Data Setup Time (w.r.t CLK)	t_{SU}	4.0	-	ns
Data Hold Time (w.r.t CLK)	t_{HD}	4.0	-	ns

Notes:
Power supplies must be stable

15.2 Data Output Operation & Timing

Figure 33: SDR Data Output Operation & Timing

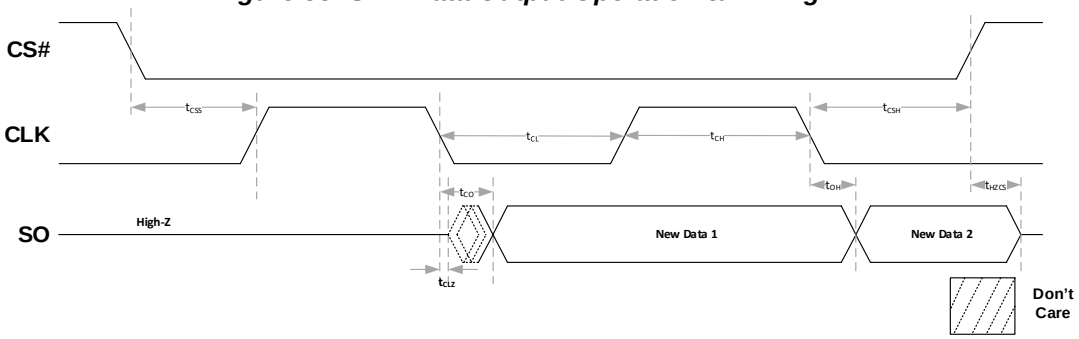


Table 39: SDR Data Output Operation & Timing

Parameter	Symbol	Minimum	Maximum	Units
CLK Low to Output Low Z (Active)	t_{CLZ}	0	-	ns
Output Valid (w.r.t CLK)	t_{CO}	-	7.0	ns
Output Hold Time (w.r.t CLK)	t_{OH}	1.0	-	ns
Output Disable Time (w.r.t CS#)	t_{HZCS}	-	7.0	ns

Notes:
Power supplies must be stable

Figure 34: DDR Data Output Operation & Timing

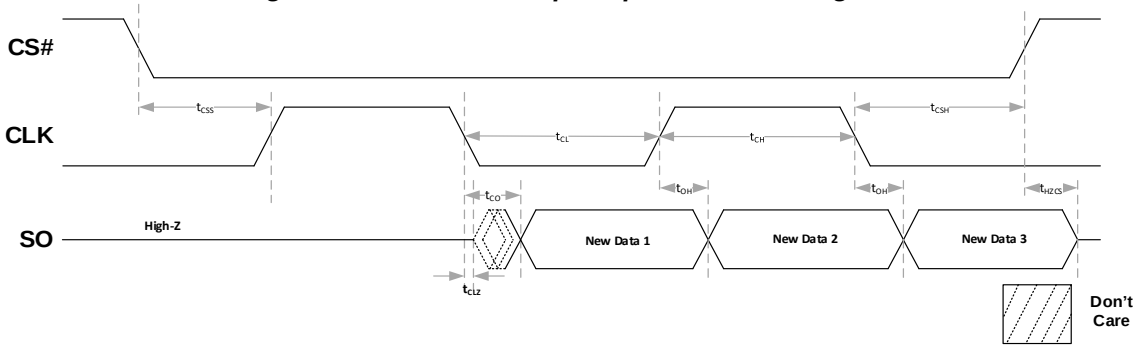


Table 40: DDR Data Output Operation & Timing

Parameter	Symbol	Minimum	Maximum	Units
CLK Low to Output Low Z (Active)	t_{CLZ}	0	-	ns
Output Valid (w.r.t CLK)	t_{CO}	-	7.0	ns
Output Hold Time (w.r.t CLK)	t_{OH}	1.0	-	ns
Output Disable Time (w.r.t CS#)	t_{HZCS}	-	6.0	ns

Notes:
Power supplies must be stable

15.3 WP# Operation & Timing

Figure 35: WP# Operation & Timing

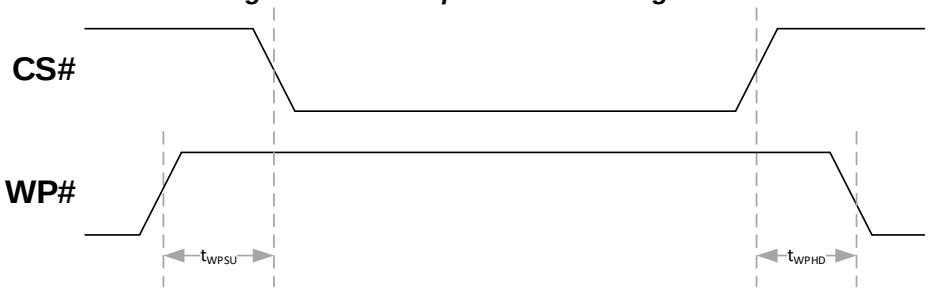


Table 41: WP# Operation & Timing

Parameter	Symbol	Minimum	Maximum	Units
WP# Setup Time (w.r.t CS#)	t_{WPSU}	20	-	ns
WP# Hold Time (w.r.t CS#)	t_{WPHD}	20	-	ns

Notes:
Power supplies must be stable

JEDEC Reset Operation & Timing

Figure 36: JEDEC Reset Operation & Timing

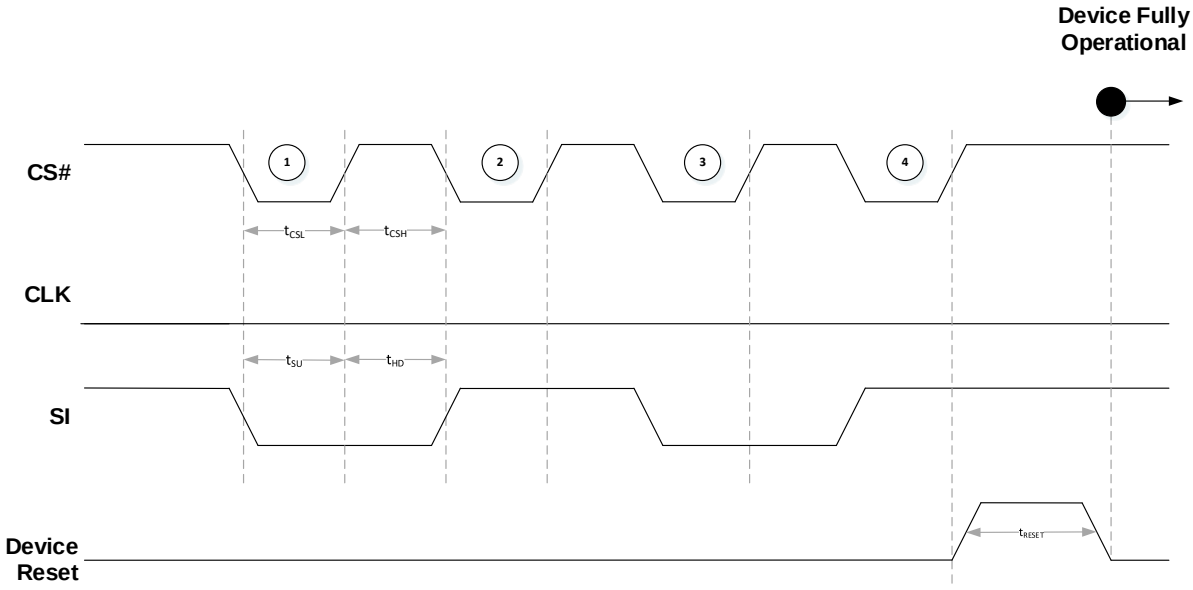


Table 42: JEDEC Reset Operation & Timing

Parameter	Symbol	Minimum	Maximum	Units
CS# Low Time	t_{CL}	1.0	-	µs
CS# High Time	t_{CH}	1.0	-	µs
SI Setup Time (w.r.t CS#)	t_{SU}	5.0	-	ns
SI Hold Time (w.r.t CS#)	t_{HD}	5.0	-	ns
JEDEC Hardware Reset	t_{RESET}	-	450.0	µs
Software Reset[1]	t_{SRST}	-	50.0	µs

Notes:
Power supplies must be stable
1: Software Reset timing is for Instruction based Reset (SRST)

Enter Deep Power Down Command (EDP – B9h)

The command sequences are shown below. Executing the Enter Deep Power down (EDP) command is the only way to put the device in the deep power down mode. The device consumption drops to I_{DP}.

The deep power down mode subsequently reduces the standby current from I_{SB} to I_{DP}. No other command must be issued while the device is in deep power down mode.

To enter the deep power down mode, CS# is driven low, following the enter deep power down (EDPD) command, CS# must be driven high after the eighth bit of the command code has been latched in or the EDP command will not be executed. After CS# is driven high, it requires a delay of t_{EDPD} (Table 6 and 7) before the supply current is reduced to I_{DP} and the Deep Power Down mode is entered. The command can be issued in SPI, DPI or QPI modes.

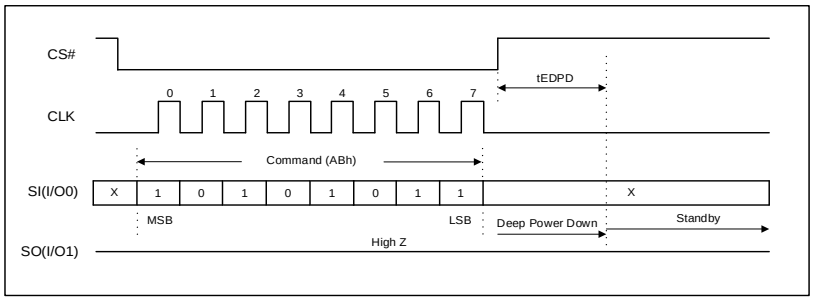


Figure 37: **Enter Deep Power Down in SPI Command Sequence**

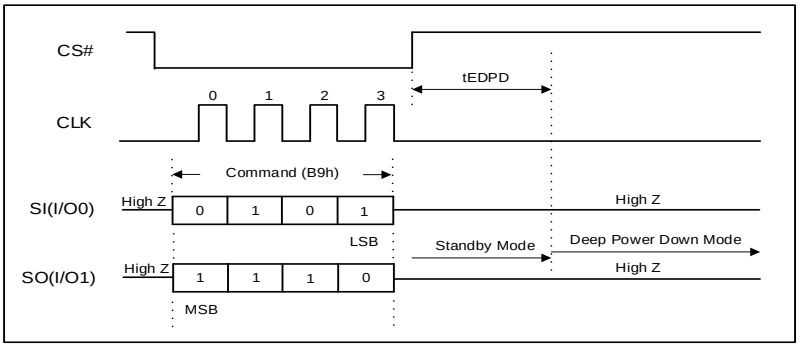


Figure 38: **Enter Deep Power Down in DPI Command Sequence**

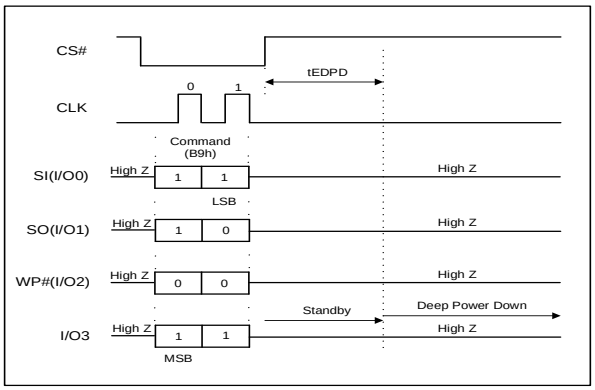


Figure 39**: Enter Deep Power Down in QPI Command Sequence**

Exit Deep Power Down Command (EXDPD - ABh)

The command sequences are shown below. There are two ways to exit deep power down mode:

1. Toggling CS# with a CS# pulse width of tCSDPD while CLK and I/Os are Don't Care. During waking up from deep power down, I/Os remain to be in high Z.

2. Driving CS# low follows with the Exit Deep Power Down (EXDPD) command. CS# must be driven high after the eight bit of the command code has been latched in or the EXDPD command will not executed.

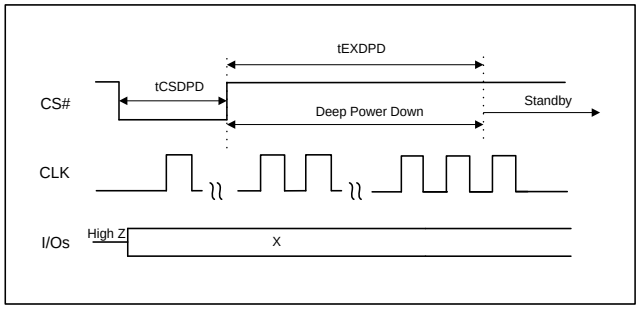


***Figure 41*: Exit Deep Power Down by Toggling CS#**

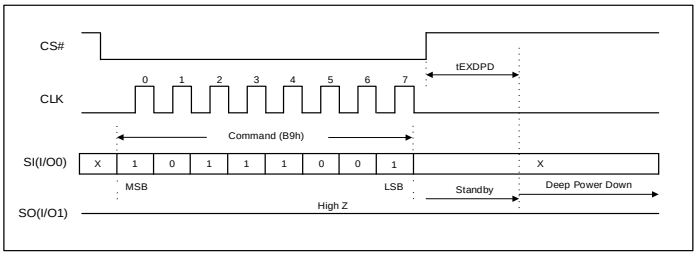


***Figure 40*: Exit Deep Power Down in SPI Command Sequence**

It requires a delay of t_{EXDPD} (Table 6 and 7) before the device can fully exit the deep power down mode and enter standby mode. The command can be issued in SPI, DPI, and QPI mode. Status of all non-volatile bits in registers remains unchanged when the SPnvSRAM enters or exits the deep power down mode.

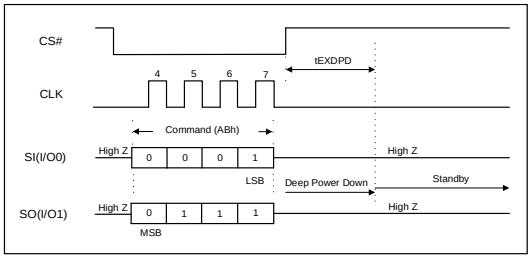


Figure 42: Exit Deep Power Down in DPI Command Sequence

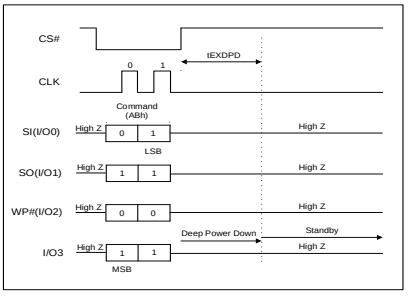


Figure 43: Exit Deep Power Down in QPI Command Sequence

Enter Hibernate Command (EHBN – BAh)

The command sequences are shown below. Executing the Enter Hibernate command is the only way to put the device in the hibernate mode. The device drops down to the lowest power consumption mode: I_{HBN}. When in hibernate mode, the CLK and SI pins are ignored and SO will be high-Z.

To enter the hibernate mode, CS# is driven low, following the Enter Hibernate (EHBN) command. After CS# is driven high, it requires a delay of t_{ENTHIB} time (Table 6 and 7) before the supply current is reduced to I_{HBN} and the hibernate mode is entered.

Toggling CS# (low to high) will return the SPnvSRAM to standby mode. The command can be issued in SPI, DPI, and QPI modes.

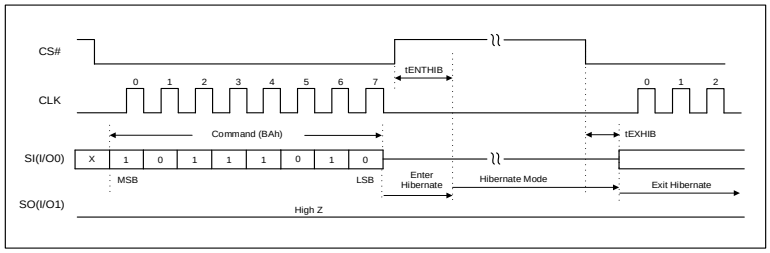


Figure 44: Enter Hibernate in SPI Command Sequence

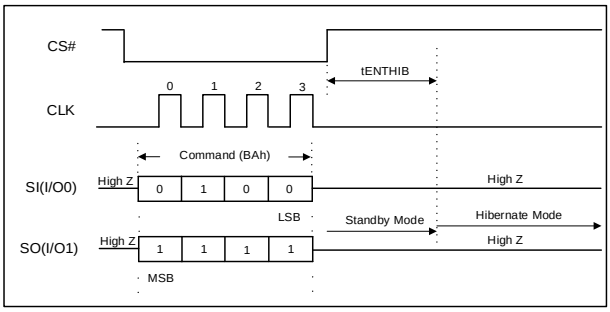


Figure 45: Enter Hibernate in DPI Command Sequence

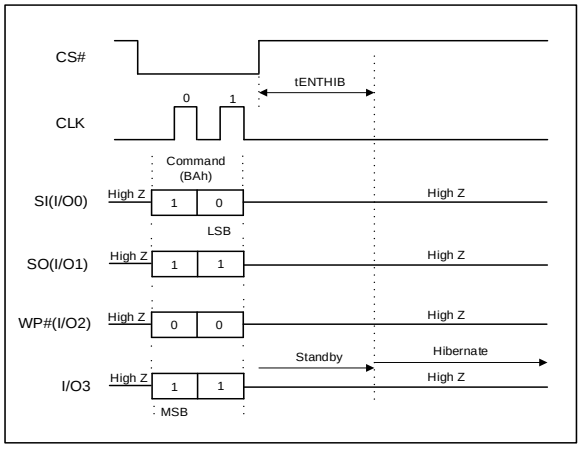


Figure 46: Enter Hibernate in QPI Command Sequence

16. Thermal Resistance

Table 43: Thermal Resistance

Parameter	Description	Test Conditions	8-pad DFN (WSON)	8-pin SOIC	Unit
θ_{JA}	Thermal resistance (junction to ambient)	Test conditions follow standard test methods and procedures for measuring thermal impedance, per EIA/JESD51	43.67	53.59	^{0}C/W
θ_{JC}	Thermal resistance (junction to case)		18.54	4.29	

Notes:
1: These parameters are guaranteed by characterization; not tested in production.

17. Revision History

Revision Date	Description of Change
Apr.16.20	Initial release.
Feb.25.21	Update to the Endurance and Electrical parameters. Thermal Resistance table added to the datasheet. Revise various tables including Tables 22, 31, 32, 33, 34, 36 and 43.

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